

Development of X-Ray microcalorimeters with doped semiconductor thermometers

Participation in investigation of the thermalization performance of superconducting absorbers and in fabrication of Ge microcalorimeters

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This training period abroad was very positive...different cultures, different working methods, and different organization in the work. The best point was the good relationship between the members of the team at the laboratory with good communication skills.

After this rich experience, I will return in France with a new approach in my professional activities.

And finally, a special thank for my two Sicilian friends Gabriella and Giorgio's House Palermo <http://www.giorgioshouse.com/> for the nice adventure. With them I have discovered a lot of beautiful places during my free time in Sicily and I will keep good memories.

Thanks for everything!

Introduction and goal

The INAF “Istituto Nazionale di Astrofisica” is the main Italian research organism for astronomy and astrophysics fields. INAF has a lot of collaborations in the world, like the Large Binocular Telescope, the European Southern Observatory, the VLBI. This institute has 19 national research centers spread all over the country and the Galileo National Telescope in the Canary Islands. There are about 1200 employees in this institute.

I have performed the training period at the “Osservatorio Astronomico di Palermo Giuseppe S. Vaiana” (OAPA), one of the research centers of INAF. In particular, my activity was held at the XACT “X-rays Astronomy Calibration and Testing” facility, which is a laboratory for the testing and development of instrumentation for X-Ray Astronomy.

One of the technological activities performed at XACT is the development and testing of Germanium x-ray microcalorimeters with main focus on array technologies and performance of absorber materials. The experimental testing of X-Ray microcalorimeters is performed using an Adiabatic Demagnetization Refrigerator (ADR) built in house.

During the first month of my training period, I visited the laboratory where the main activities were presented. I collected some information on the development of Ge microcalorimeters. And I have presented the Silicon technology developed at CEA. It was interesting to compare the technology for Ge and Si microcalorimeters. Moreover I have participated in experimental activities aimed at depositing uniform metal films by electroplating and validating the adherence. This activity is part of the technology to build array of Ge microcalorimeters.

During the second month, I have participated in a calibration program aimed at testing the performances of a small Lobster Eye X-Ray focusing system developed by a Czech Republic collaboration. The short focal length (about 35 cm) X-Ray optics was mounted onto a precision Alt-Azimuth adjustment system at one end of the 35 meters long vacuum X-Ray beam-line and illuminated with a quasi parallel beam at various energies. The images produced at the focal plane have been detected with a microchannel plate detector and have been analyzed to derive reflection efficiency and imaging performance vs. energy.

During the second and third months, my activities were dedicated to setting up and performing experimental measurements on superconducting absorbers. This activity included the mounting of the detectors inside the adiabatic magnetization refrigerator, the cool down of the cryostat, the measurements campaign and the data analysis.

Finally, I had the opportunity to attend a course on “X-rays from Star Forming Regions” organized in Palermo within the CONSTELLATION European Commission FP6 Marie Curie Research Training Network (<http://ec.europa.eu/research/mariecurieactions/>) that involves a large number of European astronomy institutions including INAF-OAPA, and to visit the electronic laboratory at INAF- Istituto di Astrofisica Spaziale e Fisica Cosmica in Palermo.

X-Ray Astronomy Mission context

X-Rays observatories are used to study the “hot universe”. Among the X-Ray missions that are still operational we can mention:

Chandra (1999 -) : an X-ray telescope with sub-arcsec angular resolution

XMM-Newton (1999 -) : an X-ray telescope (3 mirror modules) with an effective area $> 4000 \text{ cm}^2$ @ 1 keV, CCD technology (Charge Coupled Devices) with energy resolution of 120 eV @ 6 keV

Suzaku (2005 -) : high throughput thin foil X-ray optics for high resolution spectroscopy with bolometers and CCD's.

Among the X-Ray missions presently under study is the International X-ray Observatory (**IXO**) a joint participation from NASA, the European Space Agency (ESA), and Japan's Aerospace Exploration Agency (JAXA). The spacecraft configuration for the IXO study is a mission featuring a single large X-ray mirror and an extendible optical bench with a focal length of 20m and a suite of five focal plane instruments. The X-ray instruments under study for the IXO concept include: a wide field imaging detector, a high-spectral-resolution imaging spectrometer (calorimeter), a hard X-ray imaging detector, a grating spectrometer, a high timing resolution spectrometer, and a polarimeter. IXO is currently planned for launch in 2021.

With IXO, scientists will be able to study the high-energy Universe in more details than ever before and a new study on the hot universe (10 to 100 Millions of K) could be done.

This study can include :

- Super massive black holes and matter under extreme conditions (the growth of super massive black holes, study of neutrons stars, study of AGN “Noyaux actifs de Galaxies” etc...)
- Formation and Evolution of Galaxies, Clusters, and Large Scale Structure
- Life Cycles of Matter and Energy

The scientific requirement on X-ray spectroscopic detectors for the next X-Rays space mission include an energy resolution of 1 - 3 eV @ 6 keV, and an array format with at least 1000 pixels. X-Ray detectors based on arrays of microcalorimeters is widely considered as the most promising solution (Figure 1).

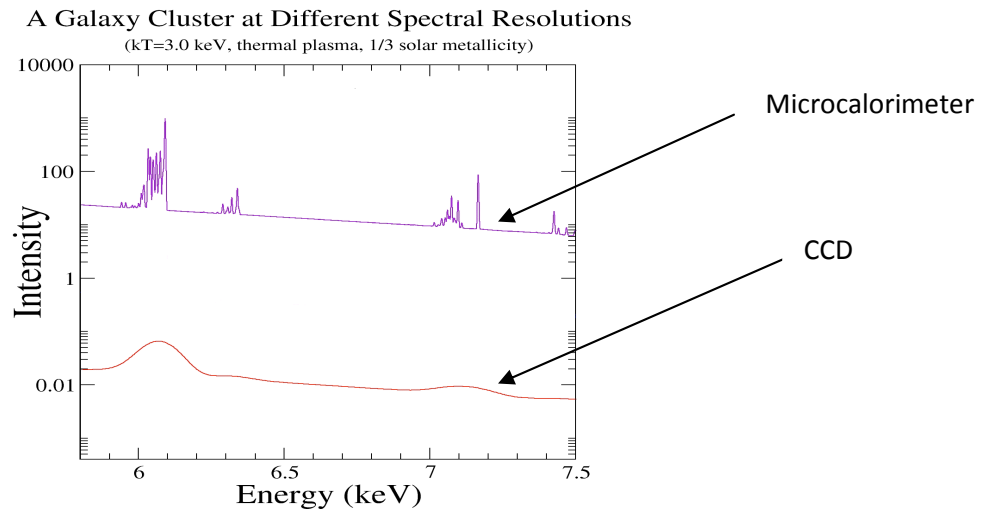


Figure 1 : A galaxy cluster with CCD and microcalorimeters

X-Ray Microcalorimeters

A microcalorimeter measures the energy deposit, due to the absorption of high energy photon. X-rays are absorbed and thermalized in a microcalorimeter composed of three parts : a low-heat capacity absorber (interaction of incident photon with the material absorber) , a thermo-mechanical link (link between absorber and thermometer) and a specific thermometer at low temperature (<100 mK). The absorbed photon produces a temperature rise which depends on its energy. This temperature rise is translated in an electrical signal by a thermometer.

The energy resolution is connected to the choice of the microcalorimeter materials. The energy resolution is given by this following expression $\Delta E = \xi \sqrt{KCT^2}$ with ξ = value depending of thermometer sensibility, K = Boltzman constant, C = thermal capacity of the system and T = temperature of microcalorimeter. To have the best energy resolution, it is necessary to work at low temperature and to reduce the thermal capacity.

Different microcalorimeter sensor technologies are under developments beside the doped semiconductors that I will discuss later in more details. We can quote the TES 'Transition Edge Sensor' developed by many teams such as SRON in the Netherlands, Goddard Space Flight Center and NIST in the United States, as well as an Italian collaboration leaded by the Physics Department of the University of Genova. The principle is to maintain the sensor at its transition temperature between normal and superconducting states where resistance is strongly dependent on temperature. The heat deposited by the absorption of an X-ray photon induces a strong variation of the electrical resistance of the sensor. The advantage of this technology is an excellent sensibility but the disadvantage is the difficulty to read this low impedance sensors and to multiplex the signals. Another promising microcalorimeter sensor technology is the Metallic Magnetic Calorimeters (MMC) with energy resolution as good as 2.7 eV at 6 keV [1].

Microcalorimeters with Semiconductor Thermistors

In doped semiconductors used as thermistors of microcalorimeters at very low temperatures, the resistivity changes with temperature, according to the variable range hopping conduction model [2]. The resistivity follows the law $R = R_o \exp(T_o / T)^{1/2}$. At cryogenic temperatures, the electrical resistance is in the Mohm range and thus high impedance pre-amplifiers can be used to read the signal pulses generated by the detectin of X-ray photons. Silicon doped by ion implantation and germanium doped by Neutron Transmutation are the most used semiconductor materials for this application.

Silicon microcalorimeter

In CEA, we develop a new technology based on implanted and high temperature diffused thermistors and an improved absorber. Each pixel of this array detector is composed of a Tantalum absorber, indium bumps and a silicon thermistor (Figure 2 and 3) [3].

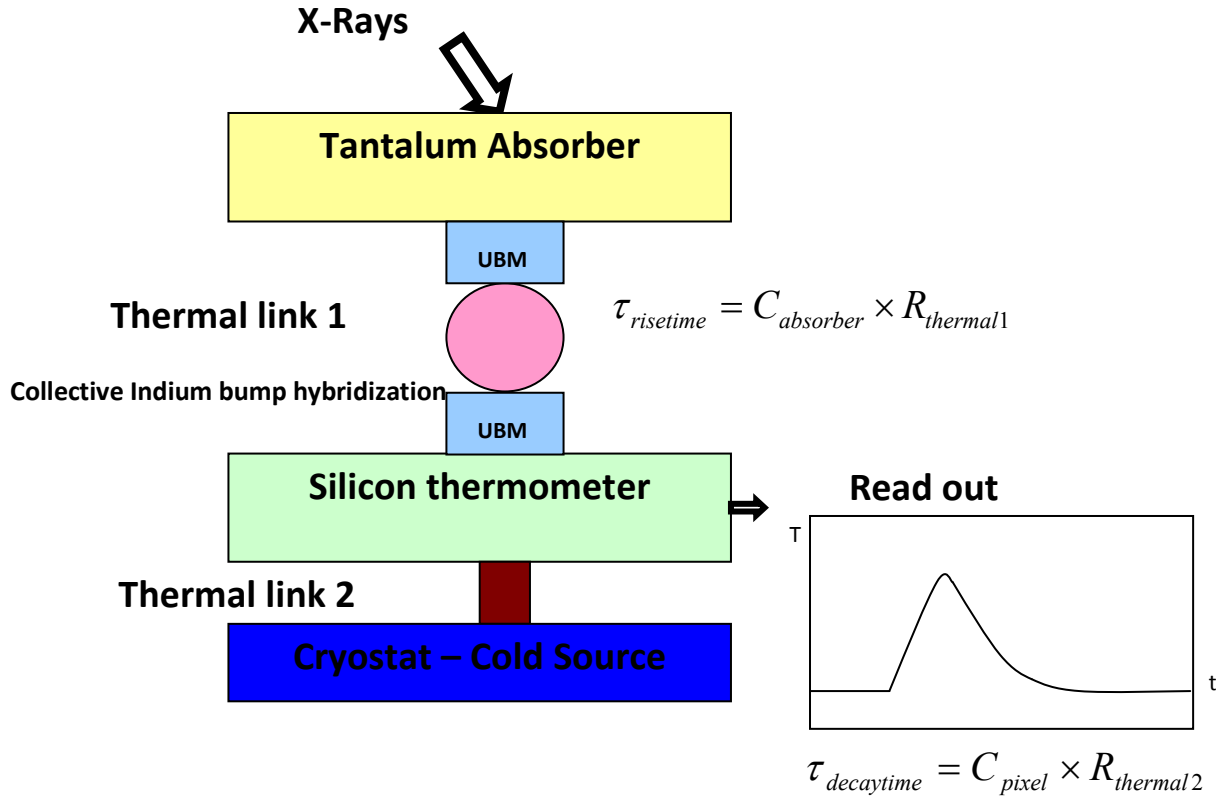


Figure 2 : Principle of Si microcalorimeter

Tantalum has been chosen as the absorber material because of its high absorption efficiency and its moderated heat capacity; tantalum has a superconducting behavior with a high transition temperature close to 4.5 K. Several physical treatments have been performed like annealing at high temperature and aluminum deposition to improve the absorber's properties like the photon energy thermalization speed.

The Silicon thermometer is composed of a 1.5 μm silicon layer suspended by four beams on the wafer silicon walls, which constitute the cold sink. The 1.5 μm silicon layer has been doped by phosphorous ionic implantation and compensated with boron. A high-temperature diffusion step allows us to homogenize the dopant concentration throughout the thermistor thickness. A thin layer of TetraEthylOrthoSilicate (TEOS) has been added on the doped thermometer to protect it. On the TEOS layer, we deposit the UBM pads used for the hybridization process.

The absorber–thermometer link is composed of an indium bump between two UBM composed of thin metallic layers deposited by standard microtechnology processes. The standard UBM process used for the electro-mechanical link is composed of Al/Ti/Ni/Au layers. In this UBM, the Ni layer is used as a metal barrier to avoid the migration of gold or indium through titanium and aluminium down to the doped silicon. Nickel is a ferromagnetic metal and does not transit to a superconducting state at any temperature. It retains an electronic contribution to the heat capacity and its influence in the overall heat-capacity budget is overwhelming. We have optimized the standard process to have good adhesion properties as well as a low heat capacity. We have decided to remove the Ni layer. A passivation layer (SiO_2) deposited on top of the silicon thermistor is used to stop any diffusion in the underlying thermometer. The indium soldering has been chosen because of its

superconducting behavior below 3.4 K and its low fuse temperature. Gold is alloyed by indium, resulting in superconducting AuIn_2 and we are left with only superconducting metals in the UBM.

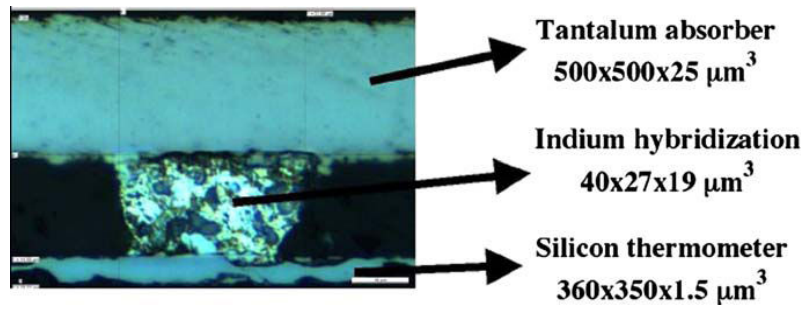


Figure 3 : Structure of Si microcalorimeter

Germanium microcalorimeter

The structure of Ge microcalorimeter is different from the Silicon technology [4]. This microcalorimeter developed at INAF is composed of a tin absorber, a thermal link between the absorber and the thermometer made of an insulating layer and a germanium (Figure 4). Currently, there is not a consolidated planar process to fabricate microcalorimeters, only manually micromanipulation techniques are used. The group at INAF-OAPA is developing a planar process to build arrays with a great uniformity and a high degree of reproducibility.

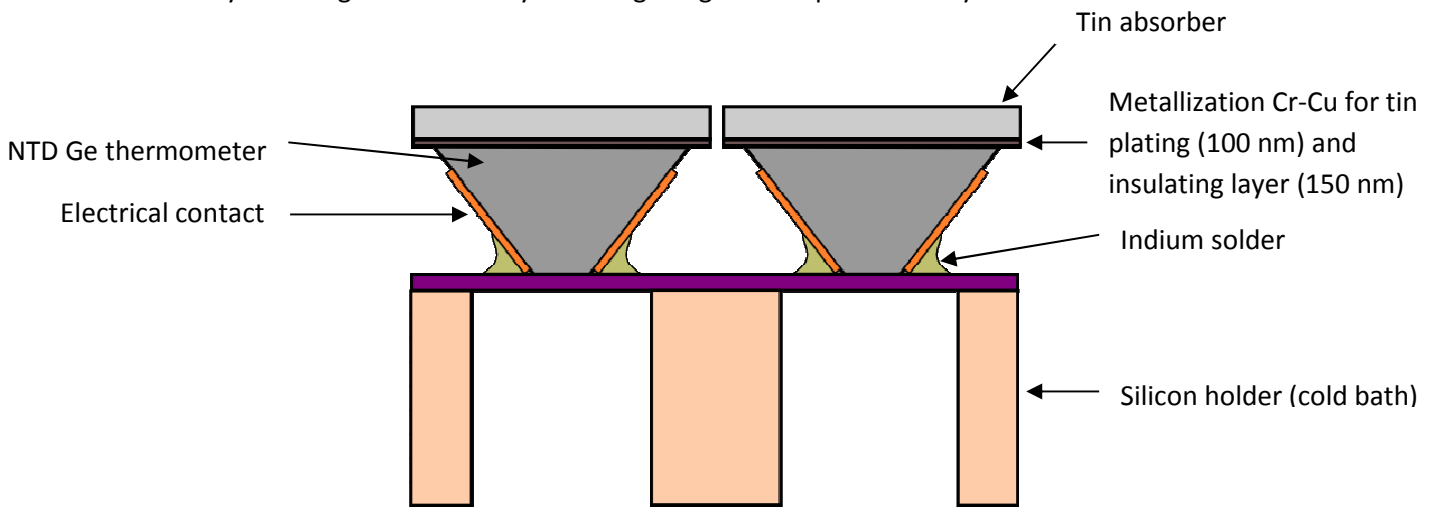


Figure 4 : Structure of Ge microcalorimeter

Single pixel devices based on doped germanium have been built with a FWHM (Full Width at Half Maximum) energy resolution of 3.1 eV at 6 keV and a quantum efficiency greater than 95%. Germanium has a low heat capacity at cryogenic temperatures, resulting in higher sensitivity. The process used for doping the germanium is the Neutron Transmutation Doping that permits to have a uniform doping concentration in the whole thickness. When germanium isotopes are exposed to neutrons beam, some isotopes undergo a nuclear transmutation. Ge^{70} becomes Ga^{71} (type p doping) that acts like an acceptor while Ge^{74} becomes As^{75} (type n doping). After finding the best neutron dose and irradiation time, this process has a good reproducibility.

The absorber layer is made of tin which has an atomic number lower than the Tantalum's atomic number. The technique used is different from the standard approach where an epoxy glue drop

maintains the absorber to the thermometer. Tin absorbs X-Ray photons in a few microns and is a superconducting material ; therefore it has a low specific heat at low temperature. An insulating layer between the absorber and the thermometer is necessary to prevent a short circuit with the sensor electrical contacts. Before building the absorber surface, a thin layer of “spin-on glass” is deposited on the germanium. This dielectric material can be deposited uniformly with a thickness as low as 150 nm.

Tin has been grown by electroplating process and this technique permits to have a pure layer with a controlled thickness. Different materials are being evaluated to make the thin conductive layer used as a seed for the electrochemical growing process. As an example a thin chrome (10nm) / copper film (100nm) is one of the material currently under study. The electroplated bath is composed of a solution of 100 g of potassium stannate trihydrate and 15g of potassium hydroxide in 1L deionized water. No additive is required in this case with this alkaline solution. An inert stainless steel anode is used in the electroplated bath, the tin atoms of the film comes from the potassium stannate ionic solution. The duration of this process is 30' and the temperature of the bath is around 70°C. The current density used is 10mA/cm² and the tin thickness is around 8 µm.

To handle the structure during the Germanium process steps, a handle is glued on the absorber. Then the germanium wafer is polished, the final thickness is around 50 µm. After this step, the standard photolithography is used to create the pyramidal shape of the thermometers, which permit to have an important exchange surface. A photomask with an array of 120 µm x 120 µm transparent squares is used. After the insulation, Ge wet-etching is performed with a mixture of phosphoric acid, ethanol and hydrogen peroxide. The etching solution allows us to have pyramidal structures (Figure 5)

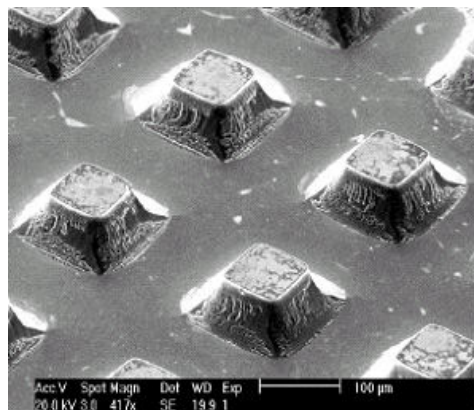


Figure 5 : Germanium thermometers structure

Then a deposition of electrical contacts is carried out through a shadow mask. Finally, indium bumps are deposited on a silicon nitride layer grown on a silicon bulk. And a Silicon etch is performed to create the thermal link through the cryogenic bath. One of the best solution for the dicing process of absorber is the use of the femtoseconds laser. This cutting process is used for the Silicon microcalorimeters.

Comparison of the two technologies

Absorber	Sn : middle Z Repeatability?	Ta : High Z Low thermal capacity Repeatability?
Thermal link	Dielectric film (good uniformity) plus chrome film	Hybridization by In bumps (collective report)
thermometer	Germanium NTD (classic technology)	Silicon implanted and diffused
Link to the cold bath	Silicon beams between sensor plate and cold bath	Silicon nitride

Development of a planar technology for the construction of arrays of Ge microcalorimeters: superconducting absorber

Rationale

Superconducting Tin has been one of the most used absorber material for NTD Ge microcalorimeters for soft X-Rays. A thick layer about 10 microns of Tin are needed to get a good absorption efficiency up to about 10 keV. Up to now NTD Ge microcalorimeters have been built by micromachining, and Tin absorbers have been obtained by thick and large foils by rolling, cutting and epoxy gluing onto the NTD Ge sensor. In the approach that INAF-OAPA is developing to build Ge microcalorimeters with fully planar processes this approach is not acceptable. Evaporation and sputtering cannot be used to deposit such thick films of metal, therefore we are trying to investigate and optimize an electroplating process to deposit a thick film of pure Tin onto the Ge wafer.

Tin deposition by electroplating

Before the tin is grown, an electrically insulating layer and a metal film (electrical conduction seed) must be deposited on the germanium. The aim of the insulating layer is to prevent the short-circuit of the germanium sensor through the absorber. We are presently using Spin-On Glass (SOG) from Filmtronics as the insulating layer on the Ge wafer. SOG is spun on the Ge wafer in liquid solution, after that it is heat treated to evaporate the solvent. The SOG film becomes hard and compact after the heat treatment.

The electroplating process permits to deposit a thick layer of metal (in the range 1 to 100 μm) on the object area, by using an electrical direct current (Figure 6). Ions Sn^{++} are in the chemical solution and permit to create the metal deposit. The throwing power is the capacity of an electroplating solution to deposit an uniform layer of metal on an object. The used solution has a good throwing power and is composed of 500mL H_2O , 50mL $\text{K}_2\text{Sn}(\text{OH})_6$ and 7,5g of KOH. An adjustable current source is used to apply the current between the inert electrode (stainless steel) and the sample inside the solution.

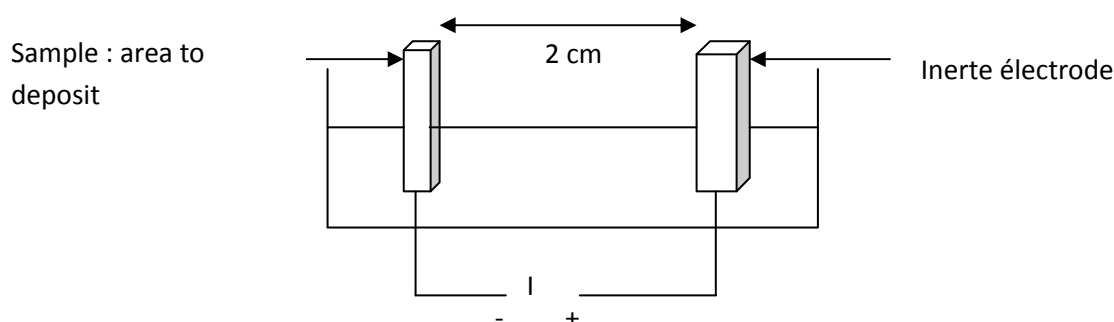


Figure 6 : Electroplating process principle

The cathode (pole -) is the place of reduction reaction ($\text{Sn}^{++} + 2 \text{e}^- = \text{Sn}$). Moreover, there is an oxygen production on the cathode surface which can cause several defects like « bumps » during the

tin electroplating deposition. Different factors can be optimized to have a uniform metal deposit, such as the chemical concentration of the electroplating bath, the deposit speed related to the current value, the optimization of the temperature.

Experimental tests on different metal film seeds

chromium

The metal film used below the absorber is used for the electroplating process and allows the plating current to circulate. The choice of the metal layer depends on the adherence on dielectric Spin-On-Glass film and on the compatibility with the electroplating process and finally on the low heat capacity. Experimental study shows the Chromium monolayer is not the best choice. The chromium has a good adherence with the SOG film but the tin deposit turns out to be not uniform presenting many defects. The chromium has not really compatibility with the tin electroplating and seems to be dissolved (Figure 7).

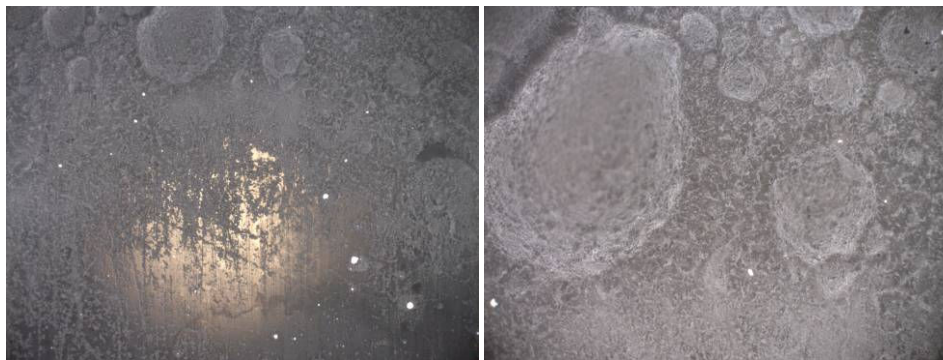


Figure 7 : Tin electroplating defects and in homogeneity in the tin deposit

chromium/copper

A second approach we have tested is to use a bi-layer Chromium/Copper because the copper has a good compatibility with the electroplating process and has a good adhesion with a chromium layer. Unfortunately, copper does not adhere on insulation film used. So it is necessary to use bi-layer materials. The chromium protected by a thin copper layer is not dissolved during the plating process. On the following picture (Figure 8), we can notice that the edges which are not protected by the copper are etched with lift-off of metal layers.



Figure 8 : Tin electroplating process on Chromium/Copper

Passivation on chromium and on chromium/copper

The idea is to investigate the tin electroplating on the Chromium and on the Chromium/Copper with an additional step of oxidation. Chromium and Chromium/copper samplers are immersed in hydrogen peroxide bath at 30% for 10 minutes. Then electroplating process is performed on this two samplers. The current density is $0.1 \text{ mA} / \text{mm}^2$ in a solution composed of $1\text{L H}_2\text{O}^2 + 100 \text{ g K}_2\text{Sn(OH)}_6 + 15 \text{ g KOH}$. The oxide layer protects the Chromium film and there is no dissolution of the film and we can see parts of tin deposit (Figure 9a). The oxidation of copper film seems to be removed during the plating process and there is a perfect tin deposit (Figure 9b).



Figure 9a) Tin deposit on Chromium oxidized Figure 9b) Tin deposit on Chromium/Copper oxidized

Titanium

Titanium and gold are used in the Silicon microcalorimeters developed in CEA. The idea is to try the electroplating process on a thin layer of titanium. Ti can be a good superconducting candidate which can replace the bi-layer Chromium/Copper. Moreover, titanium should adhere on SOG film. An experimental study is performed to conclude if Tin shows a good adhesion on Titanium. We use Ti foils (30 μm of thickness) supplied by Goodfellow (purity 99,6%). A first cleaning step is carried out with hydrogen peroxide at 30% for 10 min. Then, the sample is dipped in the solution composed of 40 ml H_2O + 14 mL nitric acid + 0,8 mL fluorhydrique acid for 10 min. After this cleaning step, we see that the edges of sample have been slightly etched. Finally, the sample is inserted in the

electroplating solution for 15 min. The electrolyze current is $0,1 \text{ mA} / \text{mm}^2$, the temperature solution is 70°C , the area of the sample is 225 mm^2 . To conclude, there is no adhesion of tin on the titanium layer (Figure 10a and 10b).



Figure 10a) Ti layer before electroplating tin and Figure 10b) Ti layer after electroplating tin

Gold

In the development of Si microcalorimeter, we use a bilayer Ti/Au. This couple of materials can be an interesting candidate to replace Chromium/Copper. We have tested the tin adhesion on gold pad. The adhesion of tin on gold is good and the tin deposit is uniform (Figure 11).

In the future, the use of Ti /Au can be the best choice. Ti has a good adhesion with SOG film and its superconductor behavior permits to have a low heat capacity at cryogenic temperature. Furthermore, there is a good adhesion between Ti and Au with an evaporation process and the tin electroplated deposit is very uniform.



Figure 11 : Tin plating process on Gold

Investigation of the thermalization performance of superconducting absorbers

Rationale

The absorber material of choice for X-Rays micro-calorimeters must have a small heat capacity to provide a measurable temperature rise after the absorption of a single photon, a high atomic number to provide high absorbing efficiency, and moreover, must have a fast and efficient thermalization of the deposited energy.

Normal metals would be ideal with respect to the last two requirements, however, their specific heat which is the sum of an electron contribution and a lattice contribution, according to the formula $C = \gamma T + AT^3$ with γ and A, constant values of the material, is too large at low temperatures because of the electron contribution which is linear with temperature.

Low gap semiconductors and Superconductors are considered as valuable candidates since they do not have an electronic term in their specific heat at low temperatures. What remains is the phonon contribution which is a function of the Debye Temperature of the material, at very low temperatures the specific heat can be calculated according to the formula

$$C_{ph} = 1943.8 (T/T_D)^3 \text{ [J/K}\cdot\text{mol]}$$

Both the groups in Palermo and in Paris are mostly interested in the use of superconductors. In the following, I discuss experimental tests that have been performed at the XACT facility of INAF-OAPA to investigate the thermalization performance of different candidate superconductor materials.

Energy thermalization in a superconductor absorber

The principle of a microcalorimeter depends on the conversion of the photon energy into a thermal phonon distribution in the superconducting absorber, producing a temperature rise, read out by a thermometer.

A soft X-ray Photon ($E < 30 \text{ keV}$) interacts with matter mainly by photoelectric absorption effect. The absorption of a photon produces the extraction of an electron with a kinetic energy equal to the difference between the energy of the incoming photon and the binding energy of the ejected electron. This ejected electron by multiple collisions releases its energy to the crystal lattice in phonons. In a superconducting material, at temperature below the T_C , the electrons are coupled in Cooper pairs (at lower energy than 2 free electrons). The phonons created by the energy deposited by the absorbed photon, can either escape into the thermistor, decay enharmonically to a lower energy level or break Cooper pairs to form single electrons, called quasi-particles. These quasi-particles quickly recombine into Cooper pairs emitting a new phonon of the same energy (Figure 12).

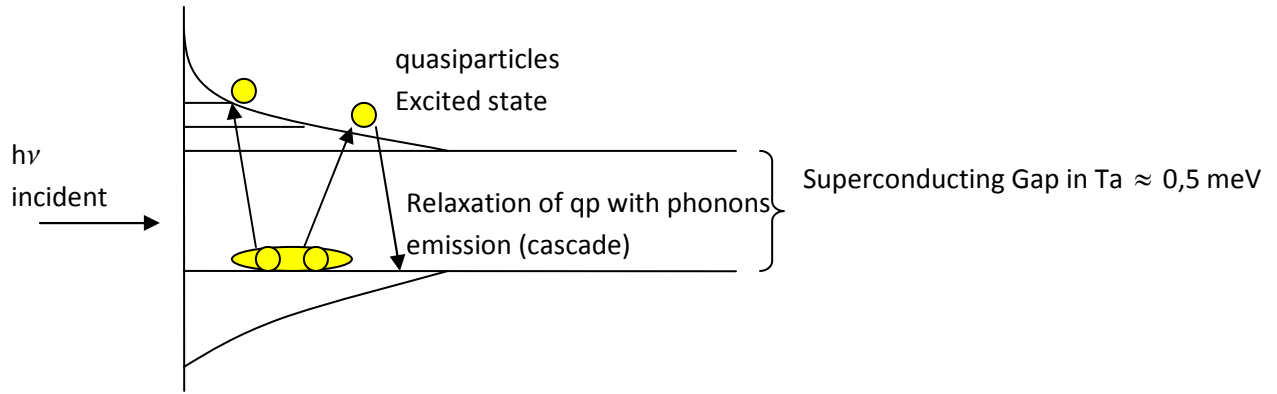


Figure 12 : Thermalization process

Since the probability to break Cooper pairs is usually much larger than the probability of the other two mentioned processes (phonons escape or decay), the time needed to thermalize the absorbed energy into a phonon distribution in equilibrium can be long compared to the rise time (depending of the thermal impedance of the link absorber-thermometer and of the thermal capacity of the absorber (Figure 2)) of the signal pulse detected by the read-out electronics. In this case a significant fraction of the absorbed energy can still be trapped in the superconductor absorber and not detected. This effect known as quasiparticle energy trapping can affect the performances of a microcalorimeter with superconductor absorber.

Most of the superconducting materials do not provide great performances in the thermalization of the energy deposited. The excess of quasiparticles reach the lowest energy level and wait for recombination. Long recombination lifetimes contribute to delay the transfer of the energy trapped and the amount of undetected energy can degrade the spectral resolution of the detector. So it is necessary to have an estimate of the percentage of energy that is effectively thermalized.

A treatment is applied on the high purity tantalum foils which come from Alpha Aesar. These foils (25 μm of thickness) are cut and cleaned in a chemical mixture composed by fluorhydric acid, acetic acid and nitric acid. The chemical attack is well controlled and the removed layer is 2 μm . A native oxide of 2nm appears on the surface of the samples. This oxide becomes instable and decays around 1500°C. We can assume that after an annealing process, the oxide has totally disappeared. It is important to outgas the material and homogenize the samples (suppression of cristal defects) by annealing at 2000°C during 2 minutes. The experimental system developed by the CSNSM permits to perform a cleaning process by Argon pulverization and annealing. It permits also to deposit metallic layers on the tantalum surface.

Last year, an experimental study has been performed on pure tantalum absorber (Ta/Au). The measurement has been performed to evaluate the percentage of energy effectively thermalized after absorption of X-Ray photons in a superconducting absorber. These measurements suggested that the formation of long living quasiparticles implies that a part of the deposited energy can not be thermalized in the time scale of the thermal sensor. An absorber prototype (Ta/Au) composed of a drop of gold (where no energy trapping is expected) and of a small piece of pure superconducting

Tantalum (glued onto the gold) was built. The experimental results demonstrated that the thermalization of photons absorbed in tantalum is delayed by energy trapping in quasiparticles.

With the Ta/Au prototype, two peaks were observed on the spectrum. In both peaks, we can see the Mn K α and Mn K β lines (Figure 13) and the sharing of the counts among the two peaks corresponds to the area ratio between the tantalum spot and the gold drop. A calibration could be performed with the higher energy peak matched to photons absorbed, fully thermalized in gold and the shifted peak corresponding to photons absorbed in Tantalum. The energy shift is 1,8 keV. We conclude that 30% of the deposited energy is not thermalized in the tantalum due to the trapping by long living quasiparticles. The effective life time of quasiparticles is around 900 μ s for pure tantalum with thermal treatment, which is important compared with an expected rise time of 100 μ s for a microcalorimeter .

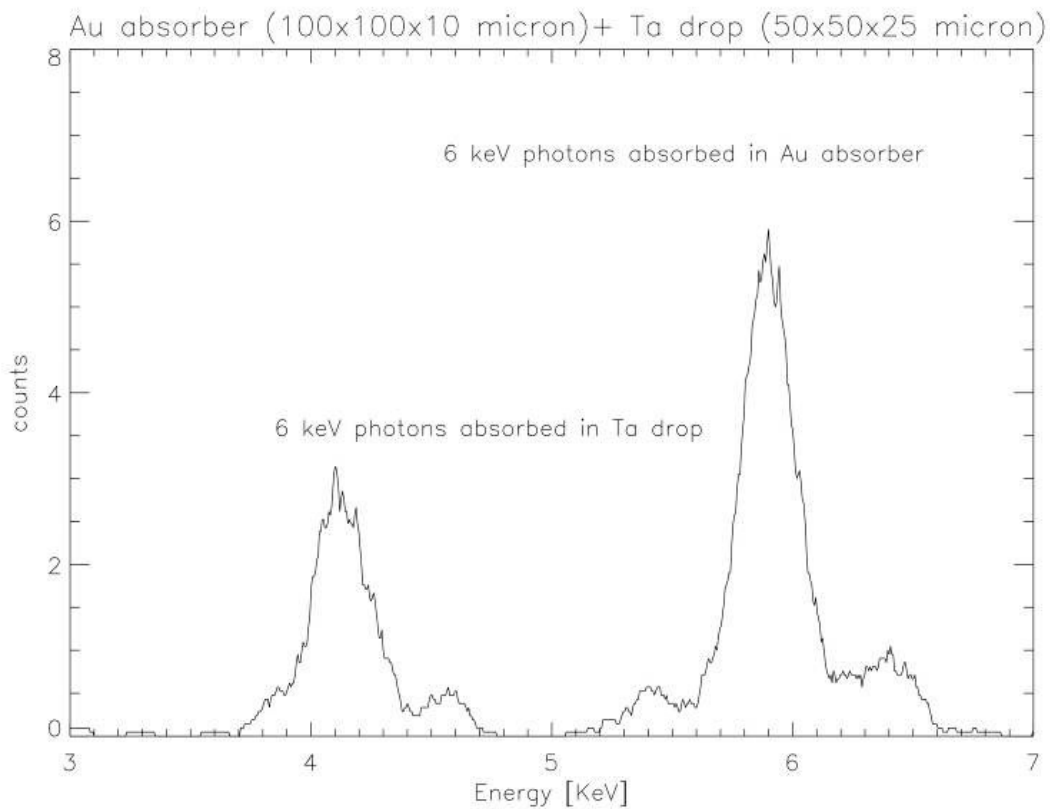


Figure 13 : Two peaks on Ta/Au absorber

One solution could be to force the quasiparticles recombination in Cooper pairs by the use of a thin layer of Aluminum or Nickel (on one side of the tantalum surface) to create a potential well for quasiparticles. The high density of quasiparticles achieved in this thin layer accelerates the thermalization process. The quasiparticle confinement in a small volume should promote the recombination process (Figure 14).

The goal of this new measurements campaign is to study the thermalization of the energy in an X-Ray microcalorimeter with Ta-Al/Au (Tantalum with one side thin Al layer glued on a gold drop).

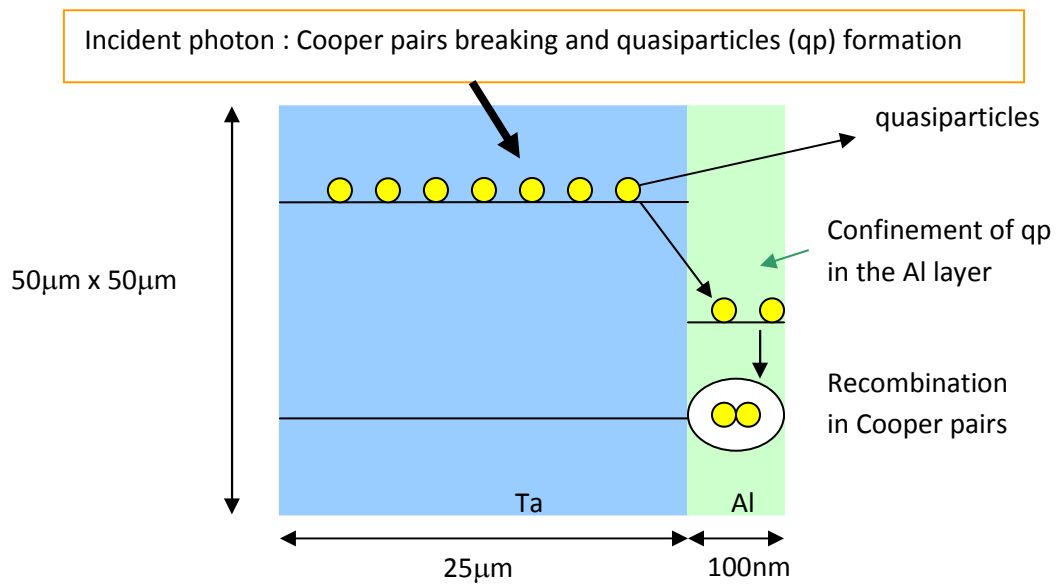


Figure 14 : Principle and structure of Ta-Al/Au prototype

Description and operation of the experimental setup

Measurements on the NTD Ge micro-calorimeters with various absorbers have been performed at temperatures between 50 and 100 mK. The following figure 15 illustrates the measurement bench including the cryostat, the pumping system, and the electronic rack.



Figure 15 : Measurement bench

The main principle of an Adiabatic Demagnetization Refrigerator is explained in annex 2. The description of the paramagnetic salt used is described in annex 1. The ADR cryostat of INAF-OAPA can reach a minimum temperature of 42 mK and can operate at 60 mK for several hours with an heat load onto the cold finger lower than $1 \mu\text{W}$. The operation steps of the ADR are described in annex 3, the cryostat wiring and thermometry instrumentation are listed in annex 4.

An iron 55 radioactive source has been used to illuminate the detectors. This source mounted outside the cryostat on a push-pull feedthrough emits 5.9 keV (Mn $K\alpha$) and 6.5 keV (Mn $K\beta$) X-ray photons. A shield screen can be inserted to protect the detectors from the X-ray illumination. Figure 16 shows a picture of the Iron source set-up. The microcalorimeters prototypes are illuminated uniformly without the use of a collimator.

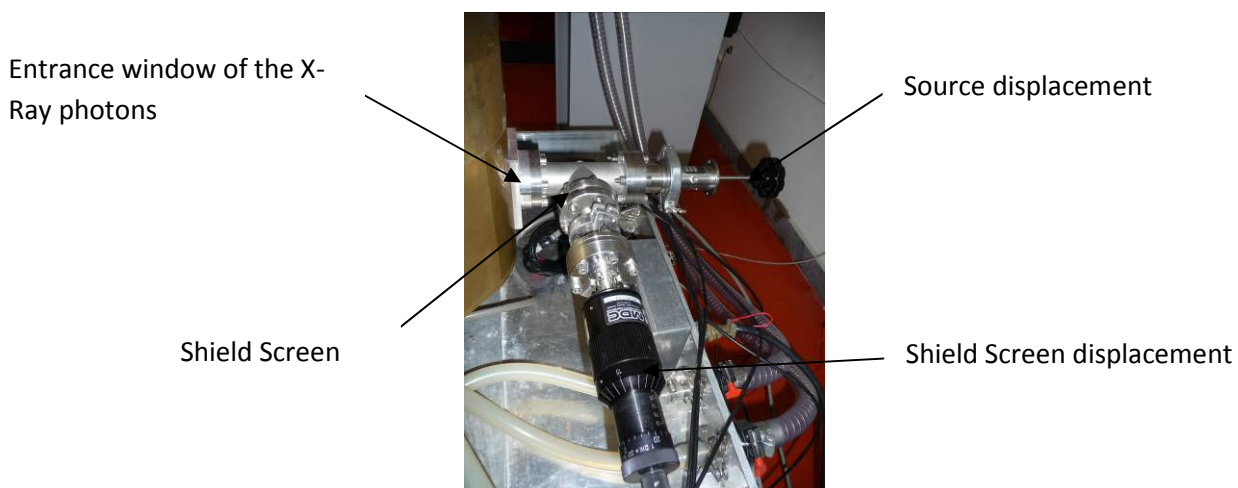


Figure 16 : Picture of Fe55 source system.

The detector box is protected from the radiation heat load by a set of three aluminized Mylar windows at the various temperature shields. The thickness of one layer of Mylar is 43 μm . The total transmission of the three windows is around 70% at 6 keV (Figure 17).

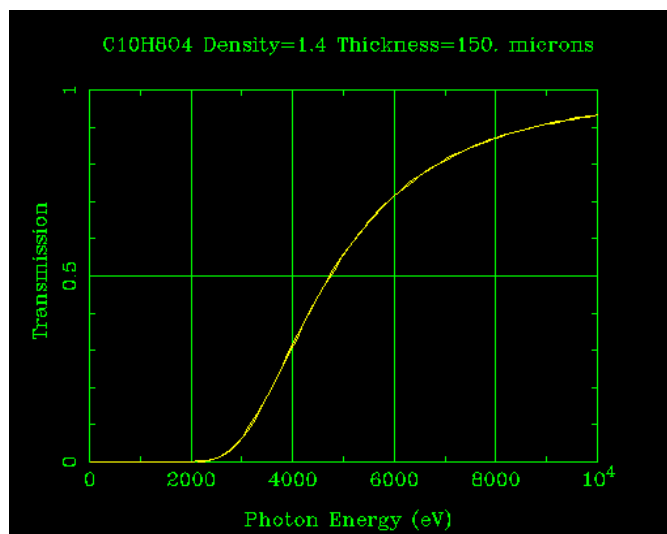


Figure 17 : Transmission curve of a MYLAR film 150 μm thick.

The electrical signals from the Ge thermometer are amplified by a first stage preamplifier mainly located at room temperature. The front-end circuit inside the cryostat includes 4 JFET transistors (4 channels) operating at 120 K located inside a box which is thermally attached to the LHe stage (Figures 18). Before cooling, the JFET circuits are checked (Annex 5). After this front-end JFET stage, there are 4 amplifiers at room temperature. So we have four electronic read out channels and it is possible to perform measurements on four microcalorimeter prototypes. The JFET circuit at 120K and the electronic at room temperature represent the preamplifier stage (Figure 19).

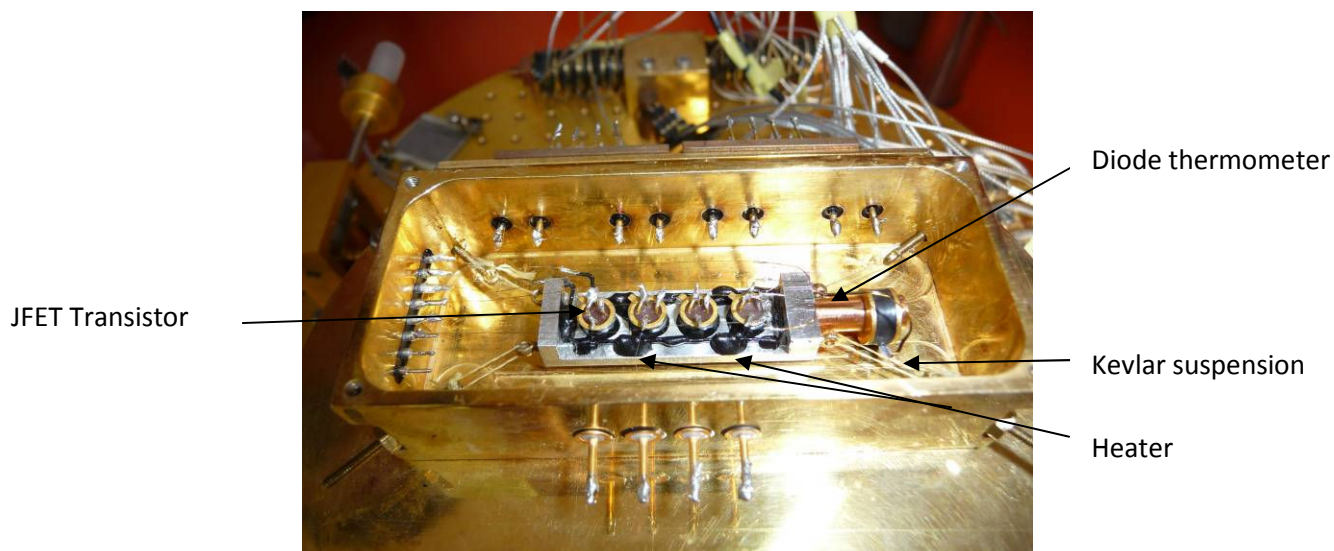


Figure 18 : Picture taken inside the JFET box.

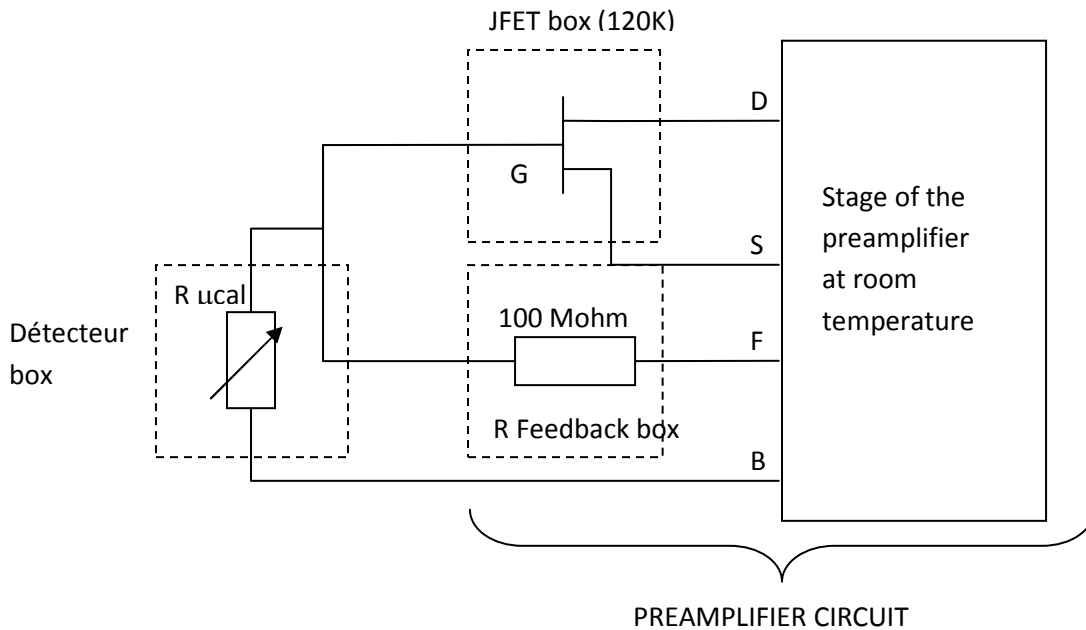


Figure 19 : Electrical diagram of the pre-amplifier circuit available for four channels.

There are two possibilities to acquire and treat the measurements data (Figure 20).

Channel A :

A pulse shaping amplifier is connected to the multi-channel analyzer and to a computer using Maestro software. The pulse shaping amplifier filters the signal time curves and a multi-channel analyzer measures the peak amplitudes of the signal pulses and fill a histogram with number of counts versus the peak amplitude. Maestro is a software that provides a histogram display for pulse heights. This histogram when calibrated is converted into an energy spectrum.

Channel B :

The signal pulses are collected directly after the preamplifier circuit without using the shaping amplifier. The signal time curves are numerised without filtering, acquired and stored in an acquisition PC under Labview. Then an off line treatment with IDL can be performed on data measurements. More details on the acquisition system can be found in [4] and [5].

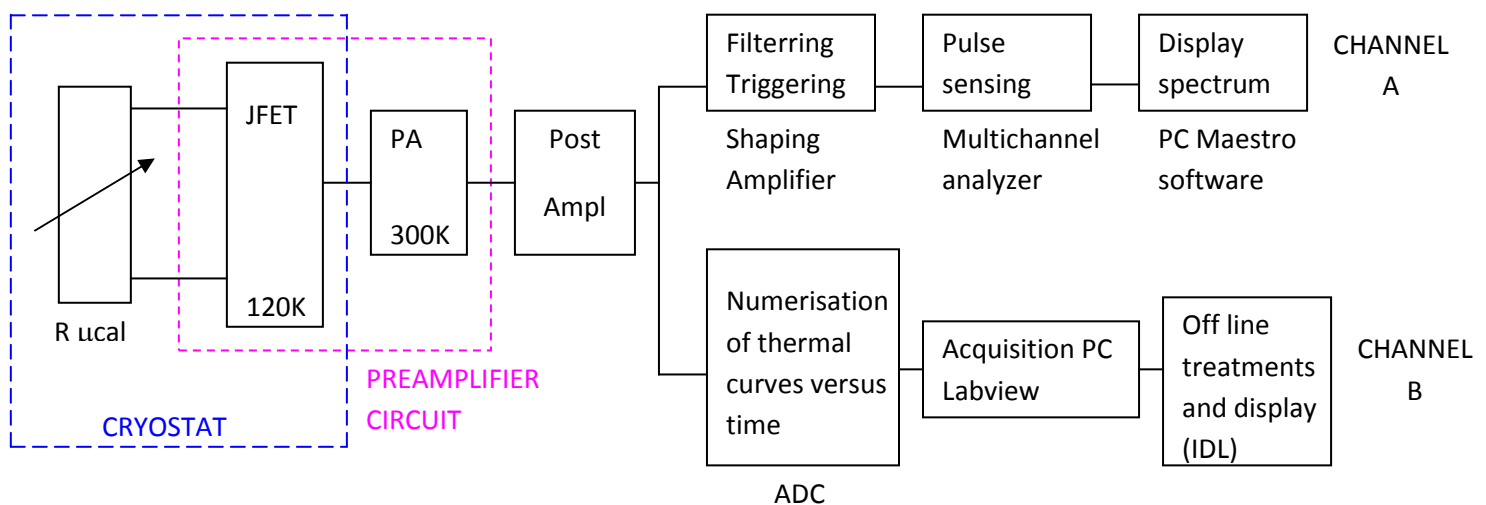


Figure 20 : Principle of measurements acquisition

Description of the detector prototypes to be tested

Samples of different superconductor materials, namely Tin, Ta, Ta+Al, Pb-Bi, Ta+Ni, WN+Si have been sent to Lawrence Livermore Berkeley laboratory (Berkeley, CA, USA) to build a set of NTD Ge microcalorimeters. Unfortunately, some of the detectors have not been built in time and we have not been able to set-up experiments to characterize all the desired samples. During my training period we have been able to set-up an experiment to test only one set of four microcalorimeters described below. A description of two more sets of microcalorimeters that are presently under design or construction is also given.

First set of microcalorimeters (built and available)

This set is composed of 4 detectors with the same kind of NTD Ge thermistor and different absorbers, namely Ta/Au, Ta-Al/Au (Al on one side), Sn/Au and Pb-Bi/Au. In order to be able to compare the thermalization performances of each superconductor material with a normal metal we have requested that a small piece of the superconductor was attached onto a thin layer of gold absorber 10 μm thick. The superconductor sample attached onto the gold is typically 50x50x25 μm^3 .

Figure 21 shows a picture of this set of microcalorimeters. The small gold absorbers with square shape about 100 x 100 μm^2 are clearly visible in the picture taken with the microscope.

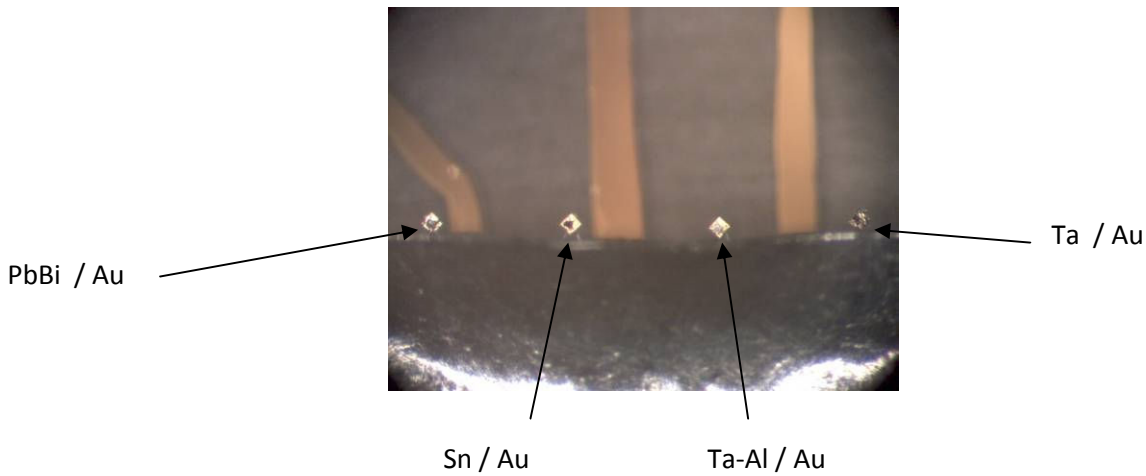


Figure 21 : First set of microcalorimeters

A 50 μm thick layer of tin (see the bottom part of figure 21) is mounted above the electrical connections of the detectors to the read-out electronics, to prevent X-ray photons to be absorbed in the wires. At 6 KeV, there is negligible transmission of X ray photons across this Tin foil (Figure 22).

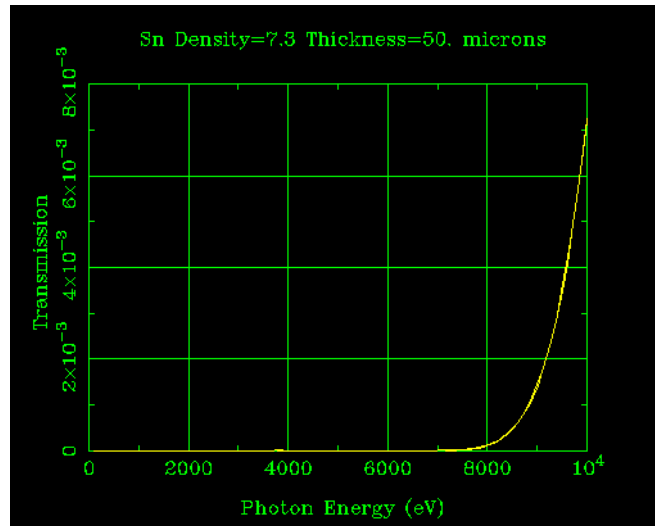


Figure 22 : Transmission curve for a layer of tin (50 μ m)

The structure of the microcalorimeter with Ta-Al absorber is described in Figure 23.

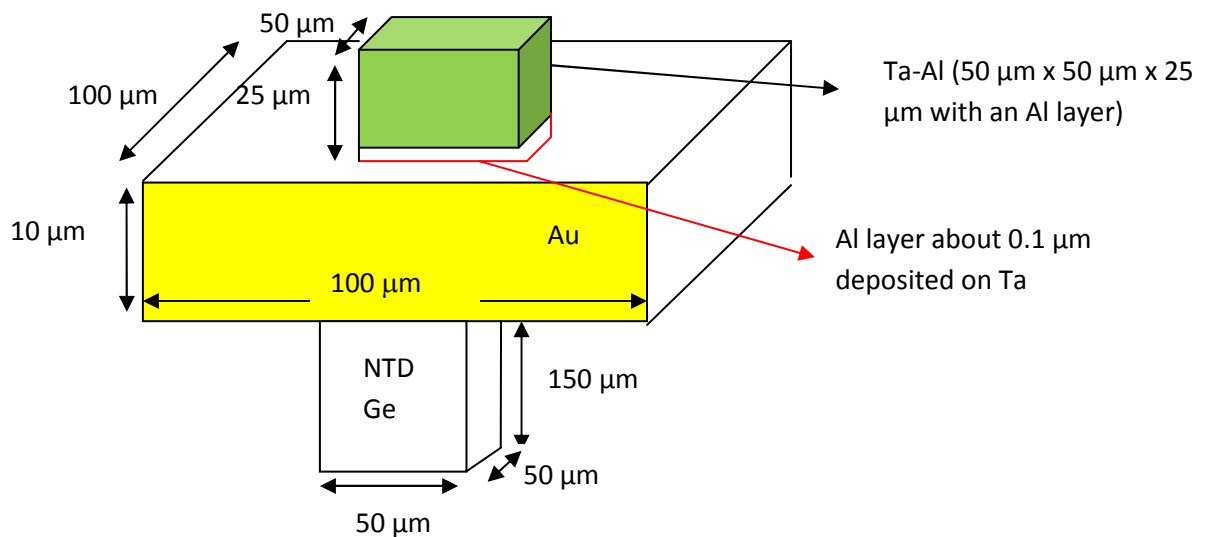


Figure 23 : Ta-Al/Au sample

The thermal link between Ta and Au and between Au and the Ge thermistor is done by hand using an epoxy glue. No automatic process is used to build this kind of microcalorimeters. The detector is mechanically suspended by the aluminum wires that provide the bias current to the NTD Ge thermistor and output the signal. The aluminum wires are ultrasonically bonded to the Ge NTD and are attached with a drop of epoxy glue onto a sapphire substrate that provides the thermal conductivity towards the cold bath. We have used NbTi wires with a diameter of 0,002 mm to connect the detectors to the read-out electronics.

Second set of microcalorimeters (currently being built and not yet available)

For this set of microcalorimeters, designed to test the following absorber materials, namely WN-Si/Au, Ta-Al/Au (Al on 2 sides), Ta-Ni/Au, and PbBi/Au, the structure of the detectors has been modified. A small piece of gold, likely $20 \times 20 \times 5 \mu\text{m}^3$ will be placed on top of the superconductor absorber. The gold volume and the heat capacitance are reduced with respect to the previous design. A collimator should be used in front of each microcalorimeter to equalize the counting rate on the gold and on the tested absorber.

Figure 24 and 25 describe the structure of the WN-Si/Au on a silicon bulk and of the Ta-Al/Au detectors. The presently available samples built on a Si bulk 700 microns thick are difficult to build on top of a much smaller size NTD Ge sensor. To reduce the thickness of Si on these samples, either by mechanical polishing or chemical etching, could damage them. The LETI laboratory in grenoble will be able to supply new samples with a thinner layer of silicon bulk.

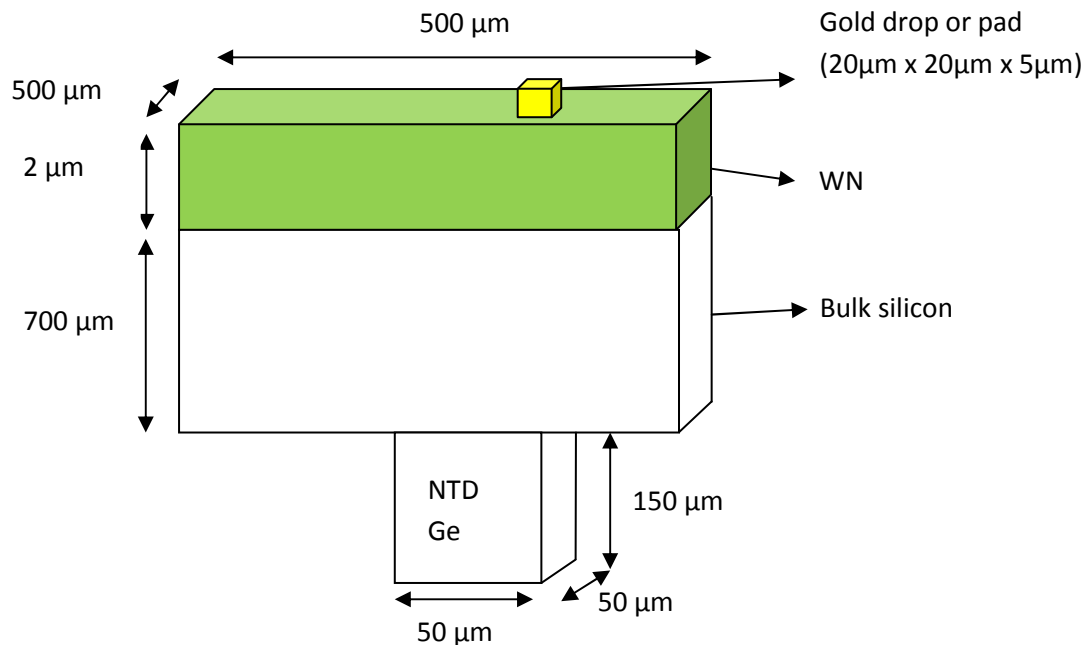


Figure 24 : Structure of Prototypes WN/Au sur Si

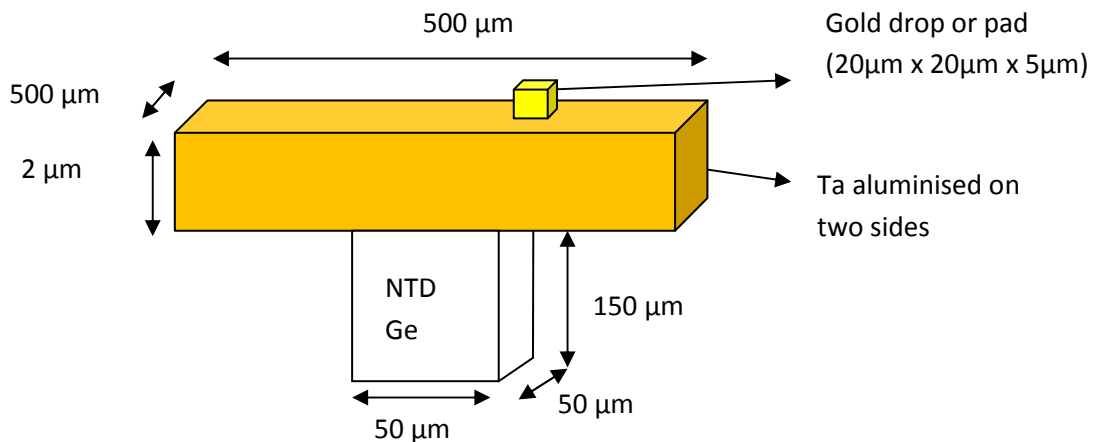


Figure 25 : Structure of Prototypes Ta-Al/Au

Given the difficulty of the American laboratory in manufacturing very small pieces of gold, one solution is that the CEA could provide the absorber with a thin layer of gold deposited (about 0.4 μm thick on the fill surface). These absorbers can then be mounted on the NTD Ge thermistors in an easier way so that we can test the new set of detectors in the near future at the XACT facility in Palermo.

Third set of microcalorimeters (currently being built and not yet available)

A third set of microcalorimeters, designed to test the following absorber materials, namely pure Tin, Tin+Sb, Tin+impurities (Fe and Co), and PbBi, has also already been built and will be tested in the future. In order to take full advantage of the measurements of this set of detectors it would be better to first optimize the experimental apparatus to reduce the significant electromagnetic ambient noise that we have experienced during the measurements described below.

Experimental results and Discussion

We have tried to collect some spectrum on the 4 absorber prototypes during the few hours when the ambient noise was lower. The spectrum for the Pb-Bi and the pure Tantalum has not been performed due to the important level of ambient noise. Only the Ta-Al/Au and Sn/Au prototypes have been measured.

Figure 26 shows pictures of the set of four tested microcalorimeters mounted inside the detector box of the cryostat.

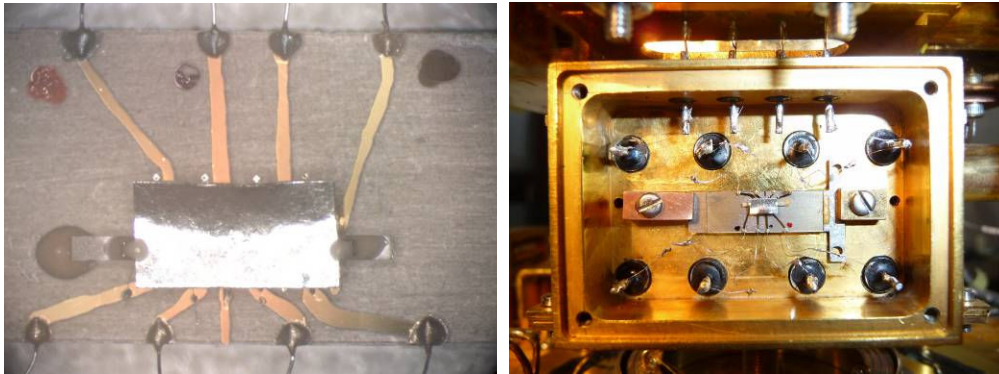


Figure 26 : On the right - tested microcalorimeters mounted inside the detector box and on the left - zoom of the absorbers area

Ta-Al/Au

For our measurements, a thin layer of aluminum has been deposited at the Ta/Au absorber. Gold is a noble metal, has not a superconducting behavior at low temperature and has a good heat conduction. We expect that the thermalization properties are excellent and that 100% of the energy of the photons absorbed in gold is fastly thermalized. The fact that we add a layer of aluminum should improve the thermalization process in the Ta-Al absorber and we would like to compare with the Ta/Au absorber.

To perform Ta-Al/Au measurements, we acquired the data from channel A (Figure 18). These measurements are filtered by the pulse shaping amplifier and the multichannel analyzer connected to the Maestro PC permits to have a spectrum. The figure 27 shows the measured spectrum for the Ta-Al/Au at 60mK as displayed directly by the Maestro program. An energy scale has been added on the following spectrum, by assuming that the maximum of the spectrum corresponds to the 6 keV line, but it is not the best solution. We do not see two peaks, one of which could be attributed to gold, so, in fact, it is not possible to calibrate the spectrum in energy.

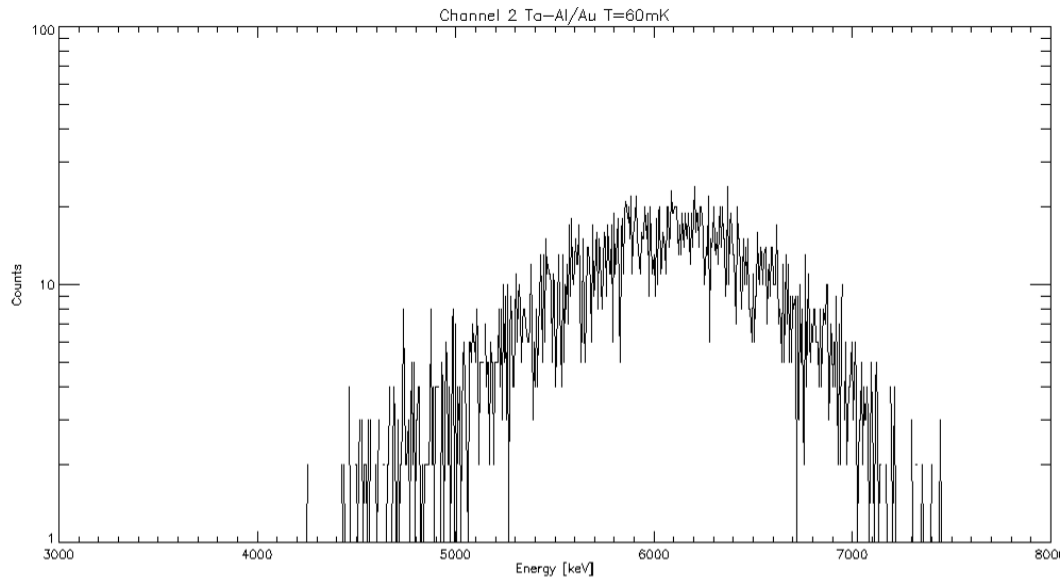


Figure 27 : Plot of spectrum for Ta-Al/Au (data extracted from Maestro program)

We have smoothed the measurements on Ta-Al/Au using a running average on 16 points to improve the readability (Figure 28).

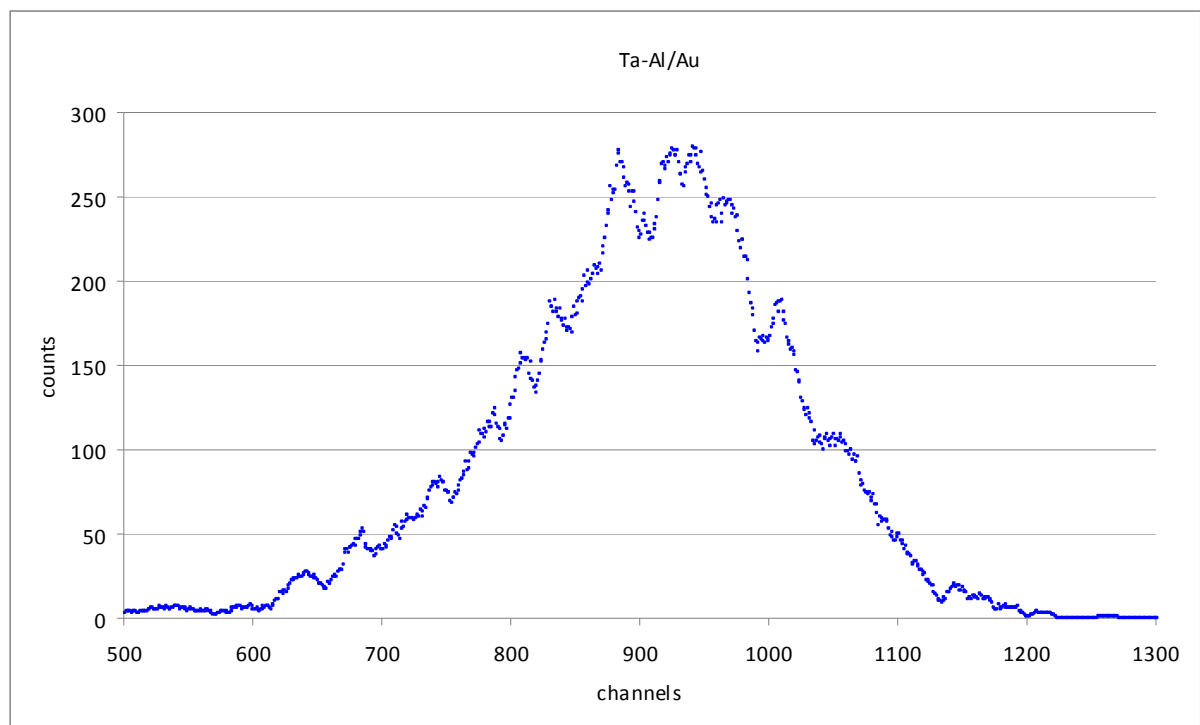


Figure 28 : Spectrum for Ta-Al/Au (smoothing treatments)

We assume that the mean value of the spectrum corresponds to the 6 keV line. And in this way we can convert the channel axis in energy scale.

The mean value can be deduce from the measurement by using this following formula :

$$\bar{x} = \frac{\sum_{i=1}^N p_i x_i}{\sum_{i=1}^N p_i},$$

Where p_i corresponds to the number of counts in the bin x_i

The mean value is around 910 channels which correspond to 6 keV.

The standard deviation is given by :

$$\sigma = \sqrt{\frac{1}{N} \sum_{i=1}^N (x_i - \bar{x})^2},$$

The standard deviation is around 110 channels. The Full Width at Half Maximum (FWHM) is given by :

$$\text{FWHM} = 2\sqrt{2 \ln 2} \sigma \approx 2.35482 \sigma.$$

The FWHM calculated is 259 channels, so around 1,7 keV. We do not see a distinct spectrum for gold and for tantalum, but a large spectrum with 1,7 keV of FWHM. In the case of the pure tantalum data presented in figure 13, the two peaks are separated by 2 keV and would be clearly separated even with a spectral resolution as large as the 1,7 keV FWHM of this new measurements. Then, we can conclude that the aluminum layer added on tantalum improve the recombination of quasiparticles and the thermalization process.

The second idea was to collect some pulses on channel B (signals out without shaping) (Figure 20) and we have tried to visualize a spectrum for the Ta-Al/Au with data treatments on IDL. It was a first approach to improve the measurement quality.

The following figures show a pulse collected lost in the noise (Figure 29) and a smoothed pulse (Figure 30). The Figure 31 shows the average pulse for the Ta-Al/Au absorbers.

The base line is very noisy (Figure 30) with a lot of low frequency noise. The pulse signal starts at 100ms and the base line is given by the data between 0 and 100ms on the temporal curve.

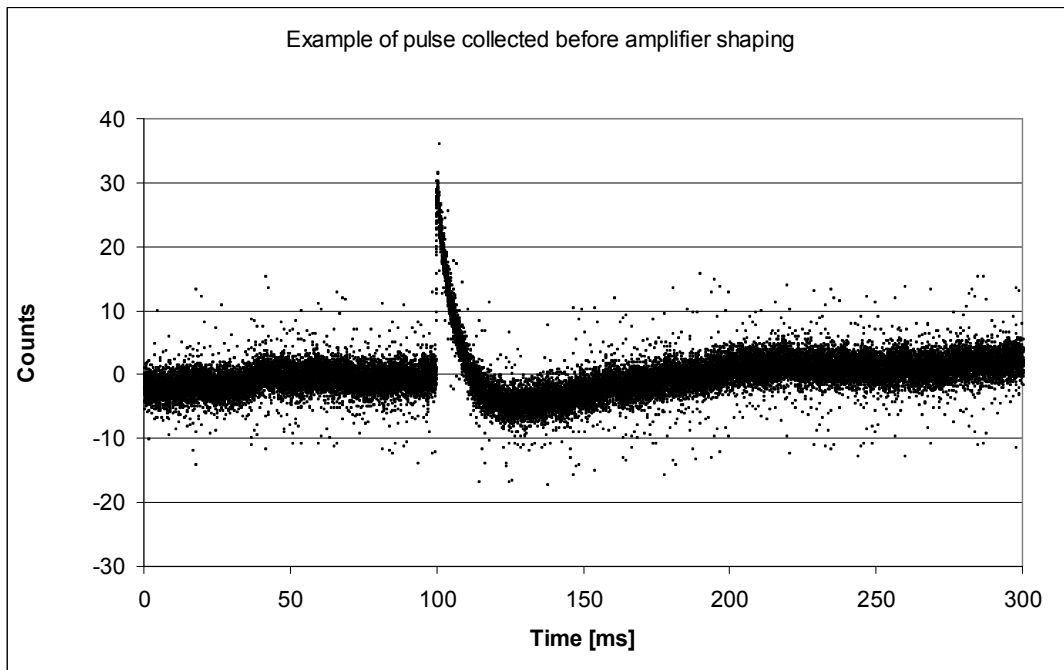


Figure 29 : Example of pulse collected

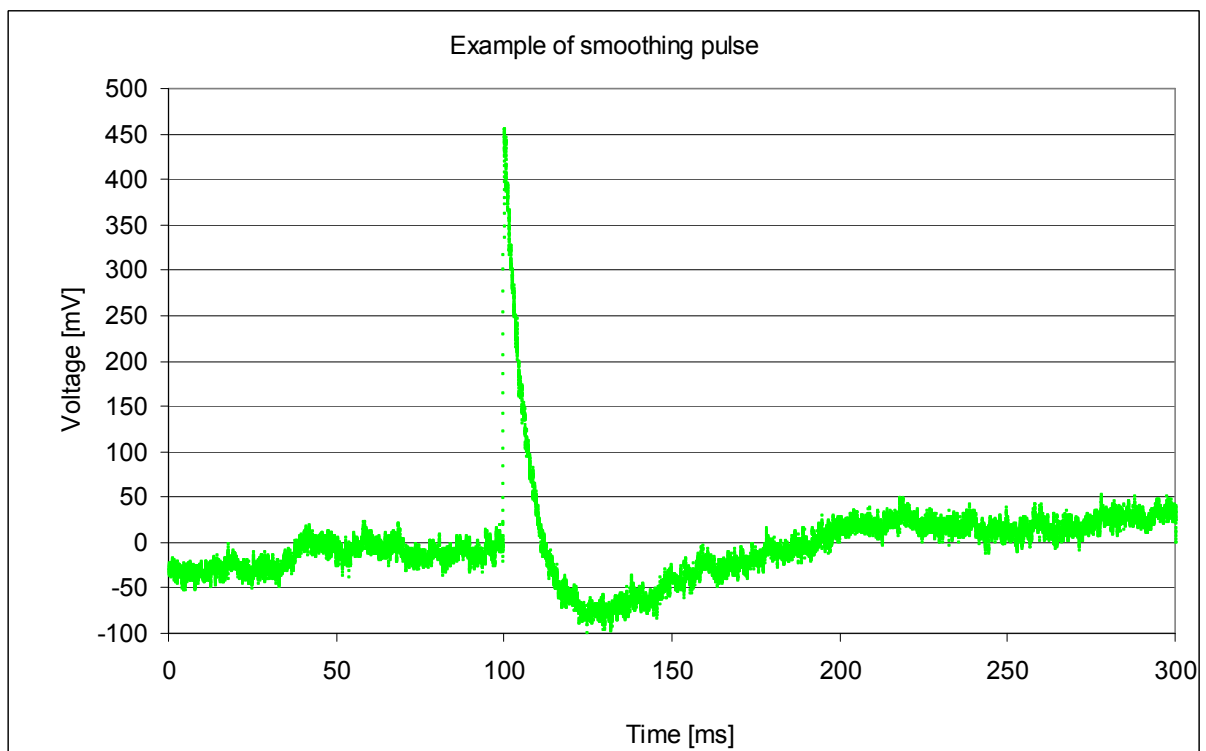


Figure 30 : Example of smoothing pulse collected

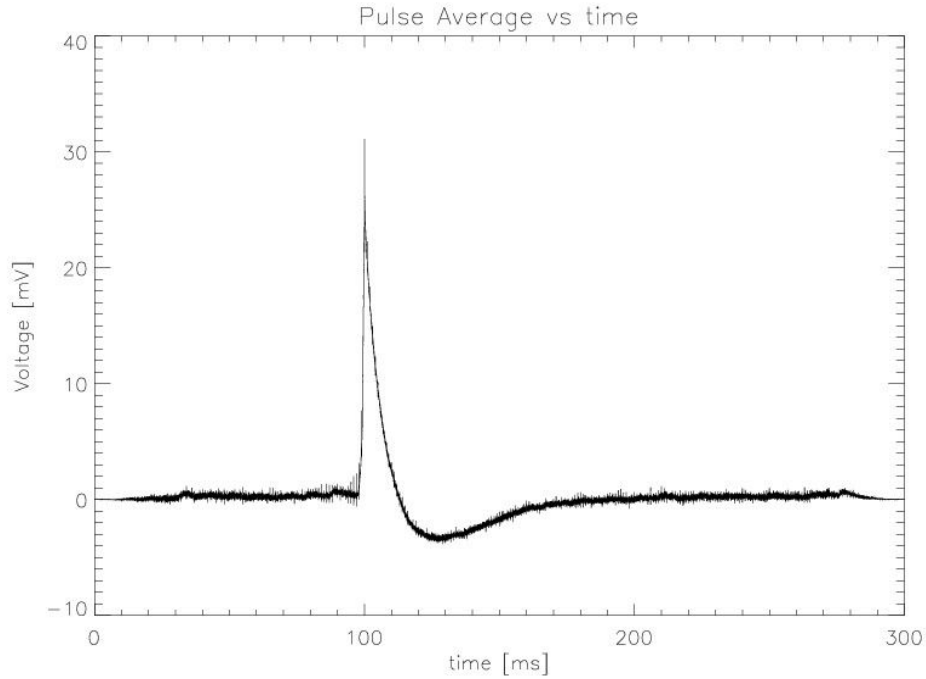


Figure 31 : Averaged pulse versus time

We tried to filter the data with an IDL treatment. It was a first approach to see if the readability of the pulses data could be improved. The spectrum with a Wiener filter is represented on the figure 32.

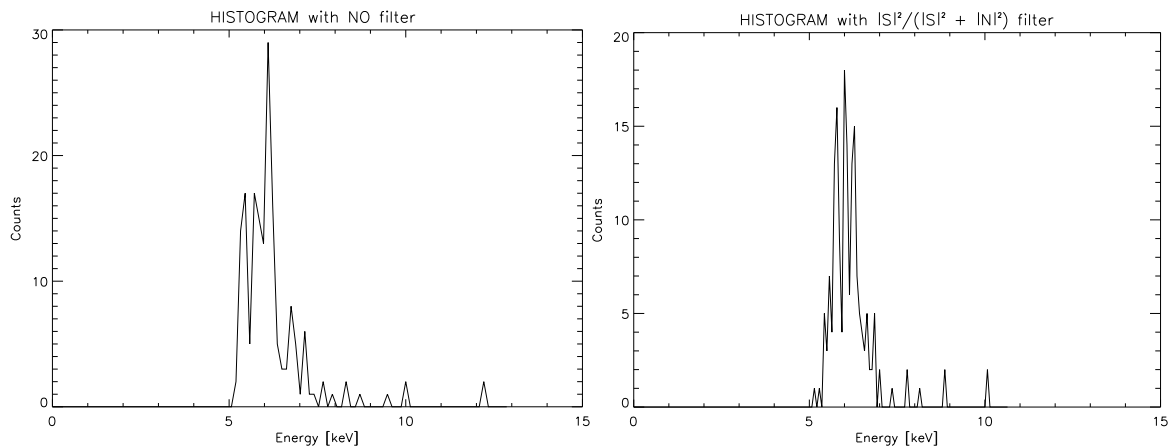


Figure 32 : Spectrum with no filter and with a Wiener filter

The observed FWHM of the Wiener filtered spectrum looks better compared with the unfiltered one. We can conclude that it is possible to improve the data by using a filter on pulses collected. It was a first approach of filtering to prove that a complete analyze with filtering should give good results. In the future, we plan to perform such an analysis.

Study of the time curves :

The last idea is to derive the decay and rise time of each pulse and evaluate if we see two populations corresponding to the detection of photons in gold and tantalum.

Most of the pulses are clustered around a rise time of $400\ \mu\text{s}$ and a decay time of $9\ \text{ms}$ (Figure 33). And we do not see any structure corresponding to two different populations. This was not the case with the Ta/Au microcalorimeter prototypes [6].

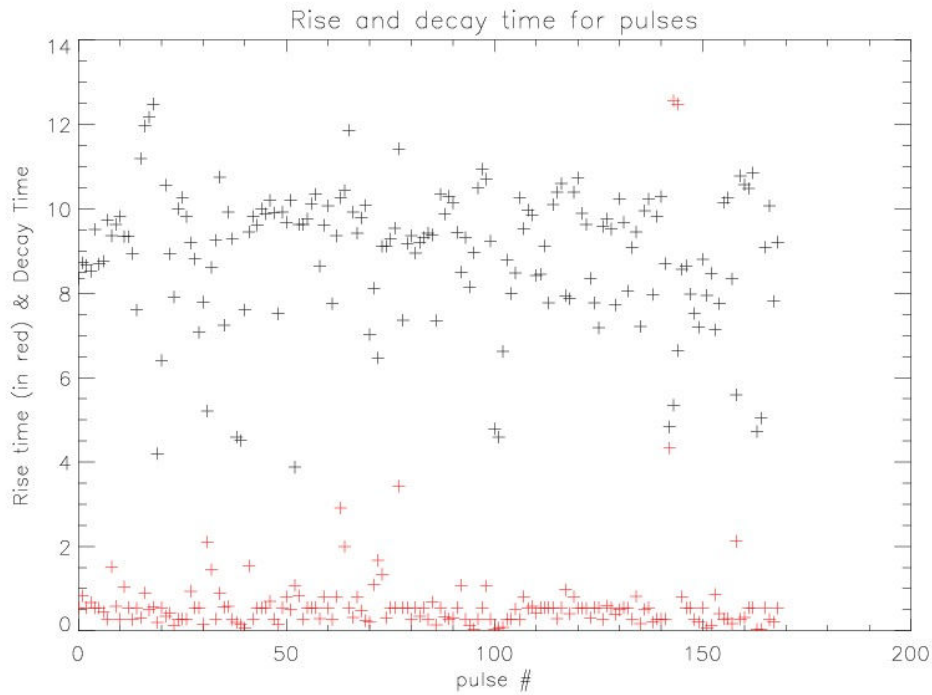


Figure 33 : Rise and Decay time for pulses collected

Sn/Au

The following figure shows the spectrum for the Sn/Au. The Sn/Au measurements have been performed at 65 mK (Figure 34) and have been acquired with the channel A (Figure 20). The Sn is a good thermalizer and it is possible to compare the Ta-Al/Au and Sn/Au spectra (Figure 35).

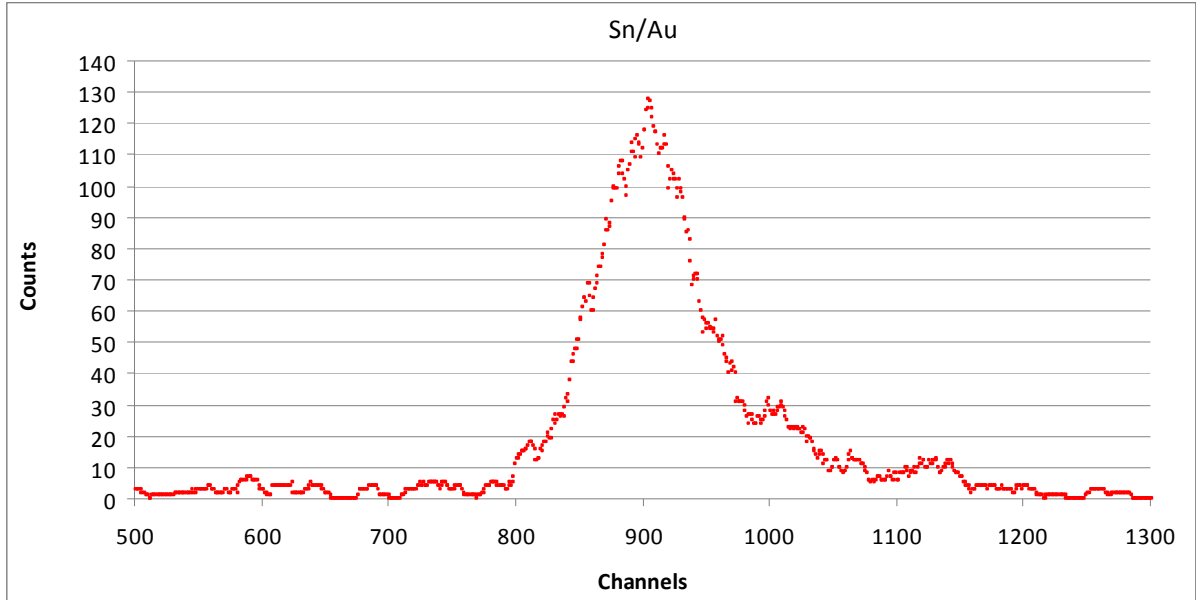


Figure 34 : Spectrum for Sn/Au (smoothing treatments)

The mean is around 921 channels which correspond to 6 keV. The standard deviation is 56 channels and the FWHM is next to 130 channels which corresponds to 0,86 keV.

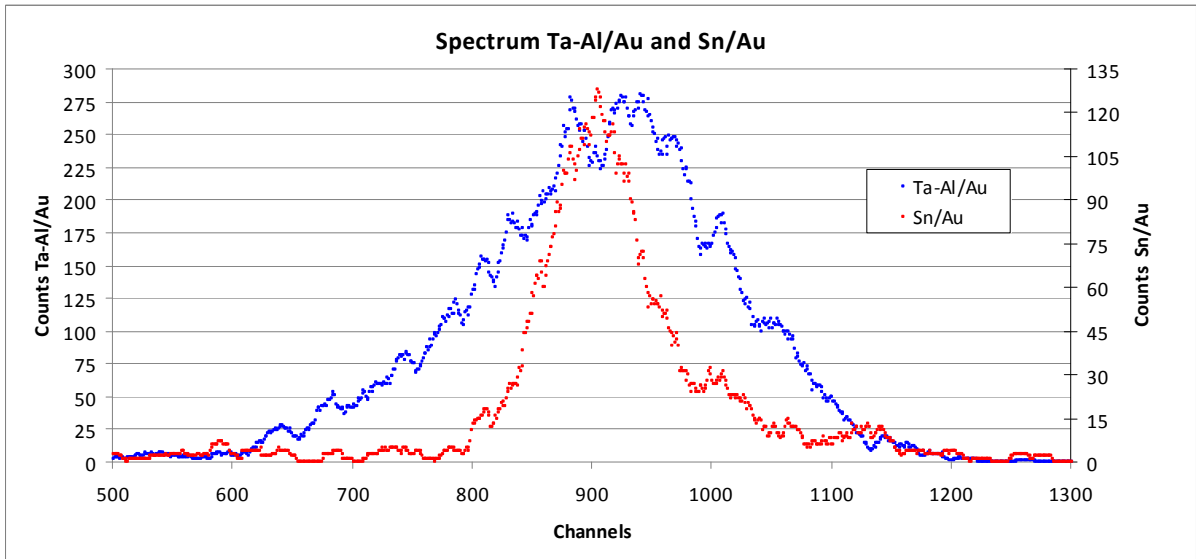


Figure 35 : Comparison of Spectrum for Sn/Au and Ta-Al/Au (smoothing treatments)

The Sn is known to be a good thermalizer. We do not visualize the 2 peaks observed with the Ta and Au (Figure 13). We can not conclude anything from the widening of the Ta-Al/Au peak compared with the Sn/Au one, as each microcalorimeter prototype had very different levels of noise, as

demonstrated by the fact that we could not take any data with the two other microcalorimeter prototypes (Ta/Au and PbBi/Au) mounted in the cryostat during this measurement campaign.

Discussion and prospective

We can conclude that the thermalization process is improved by adding the Aluminum layer on Tantalum. However, the very noisy pulses and poor energy resolution associated forces us to be prudent in the conclusions. Further analysis should be performed to verify if more accurate results can be derived from the available pulses, while a new measurement program should be scheduled after the cryostat wiring has been revised.

We can precise that some measurements have been performed in the same time at the IAS “Institut d’Astrophysique Spatiale” with a Pu238 source which show good results with a FWHM at or lower than 12 keV for alphas of the Pu source (Figure 35).

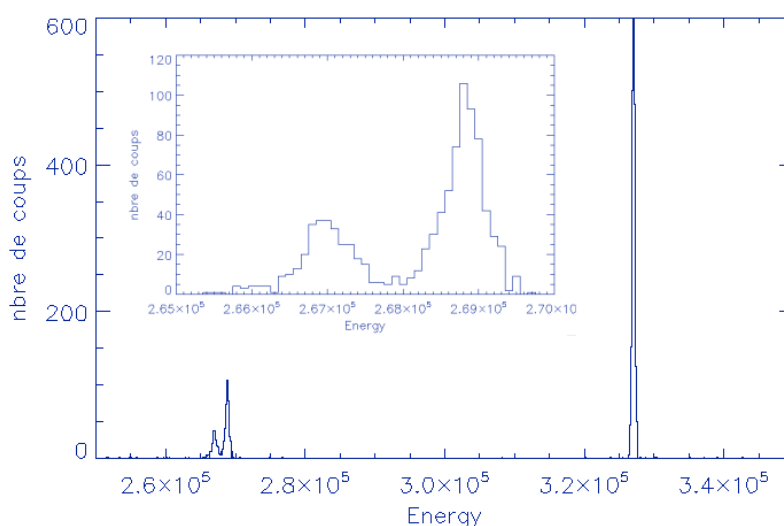


Figure 35 : Spectrum for Ta-Al/Au with Alphas of Plutonium

During the measurements in Palermo we experienced a very strong electromagnetic ambient noise which made it very difficult to distinguish the photon pulses above the noise on the oscilloscope. Furthermore, the detected rate of photons was very low (less than 1 cts/s), this is partially due to a reduced radioactivity of the Iron 55 source (more than 5 years old) and due to a non ideal mounting of the source. Only few hours during one of the nights of the measurement program the ambient noise was significantly lower and allowed us to detect a few photons.

Given the strong ambient noise that was experienced we have decided to re-analyze the wiring of the cryostat and in particular the wiring between J-FET and detector boxes that presently use un-shielded wires. Furthermore, the heater in the JFET box seems also to be a potential source of noise incoming into the J-FET box. It will be interesting to add a heater by optical fiber for example.

Moreover, the post-amplifier and pulse-shaping amplifier have been provided to INAF-OAPA by a collaborating research group in USA and there is very poor if any documentation that can be used to

optimize the performances of such devices. It is a real problem to well understand without schematic, gain, level of noise etc...

Conclusion

This training period permits to study the Germanium microcalorimeters technology and to compare with the Silicon microcalorimeters technology. Tin electroplating deposition and experimental tests allow us to optimize the standard process for the Ge microcalorimeter.

The second part of training period permits to conclude that the Ta-Al/Au absorber remains a candidate for the Silicon microcalorimeter as it has a better thermalization process than the Ta/Au absorber. Unfortunately, due to unexpected Electromagnetic Noise in the experimental set-up the measurement campaign conducted during my training period in Palermo was not fully successful, and new measurements will be performed after the ADR cryostat wiring will be revised.

References

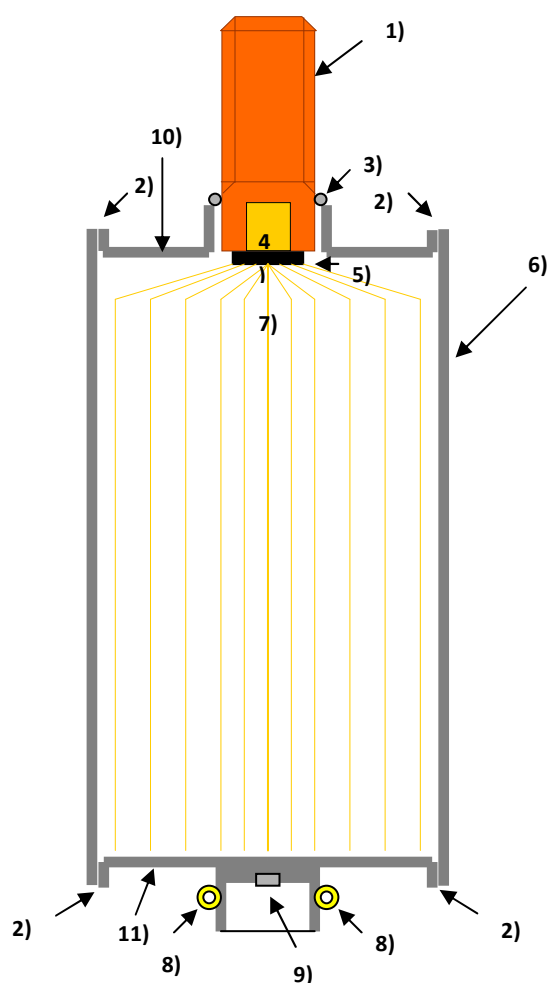
- [1] P. Verhoeven, "Photon Counting Low Temperature Detectors for Visible to Gamma Ray Astrophysics", J. of Low Temp. Phys, vol 151, May 2008.
- [2] Shklovskii, Efross, "Electronic Properties of Doped Semiconductors", Springer-Verlag, 1984
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- [5] E. Silver, "High resolution spectroscopy using germanium microcalorimeters", X-Ray and Gamma Ray Instrumentation for Astronomy and Atomic Physics, 1989
- [6] E. Perinati, "Experimental evidence of an incomplete thermalization of the energy in an x-ray microcalorimeter with a Ta/Au absorber", Review of scientific instruments, 2008

ANNEXES

Annex 1 : Paramagnetic salt used in the ADR of the INAF-OAPA

The paramagnetic salt used in the ADR of the INAF-OAPA is the Ferric Ammonium Sulphate dodecahydrate ($\text{FeNH}_4(\text{SO}_4)_2 \cdot 12\text{H}_2\text{O}$), provided by Sigma-Aldrich with a purity of 99.99%.

The paramagnetic salt must be confined in an insulated vessel to prevent the loss of the crystallized water molecules and must be in a good thermal contact with the cold finger which is a copper rod. The thin walls salt container is made of stainless steel which has a good strength and a good resistance to salt chemical etching. Gold wires (120 mm long and 0,25 mm diameter) are drowned inside the crystal container to have a good thermal link between the salt and the cold finger (Figure 36). The salt container is suspended by Kevlar wires to minimize the heat load from the helium bath.



Legend

- 1) Cu rod (cold finger)
- 2) TIG welding (caps and cylinder)
- 3) Silver soldering (cap and Cu rod)
- 4) Gold soldering (wires bundle and Cu rod)
- 5) Epoxy
- 6) Container (stainless steel INOX 304)
- 7) Gold wires bundle
- 8) Screw eyes
- 9) Vacuum seal screw
- 10) Upper cap
- 11) Lower cap

Material	Weight [g]
Stainless Steel	32.35
Gold	14.76
Copper	24.64
FAA	124.62

Figure 36 : Salt Pill container

Annex 2 : Principles of an adiabatic demagnetization refrigerator

One method to obtain cryogenic temperature below 1K is the use of the adiabatic demagnetization refrigerator (ADR). The following pictures (Figure 37) show the cryostat used for the absorbers measurements.

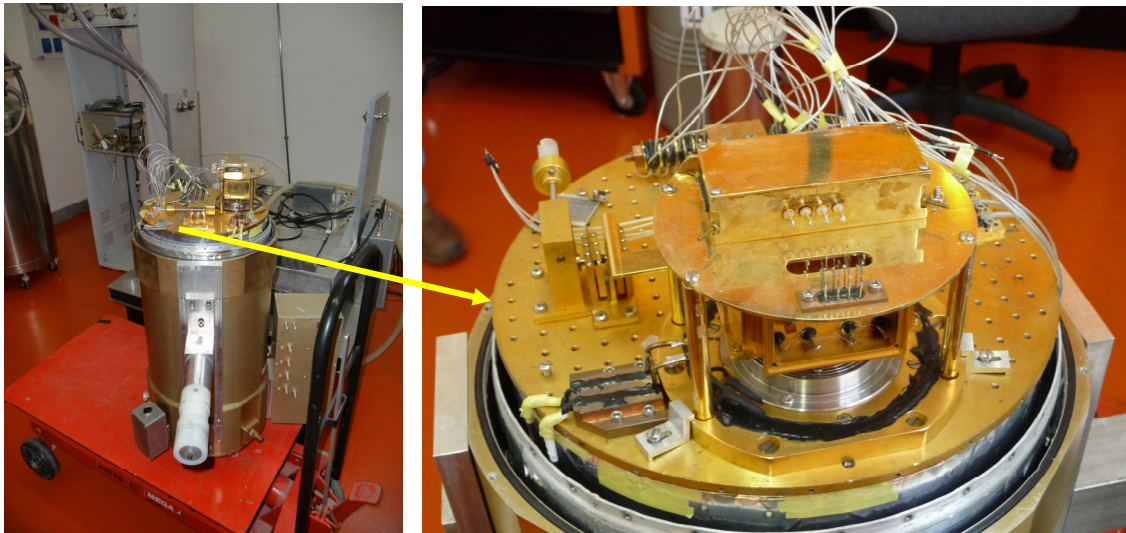


Figure 37 : overview of the cryostat and associated zoom

The main components of an ADR are: a magnet, a paramagnetic salt pill such as Ferric Ammonium Alum dodecahydrate ($\text{FeNH}_4(\text{SO}_4)_2 \cdot 12\text{H}_2\text{O}$), a thermal heat sink between the salt and a cold bath and a magnetic shield (Figure 38).

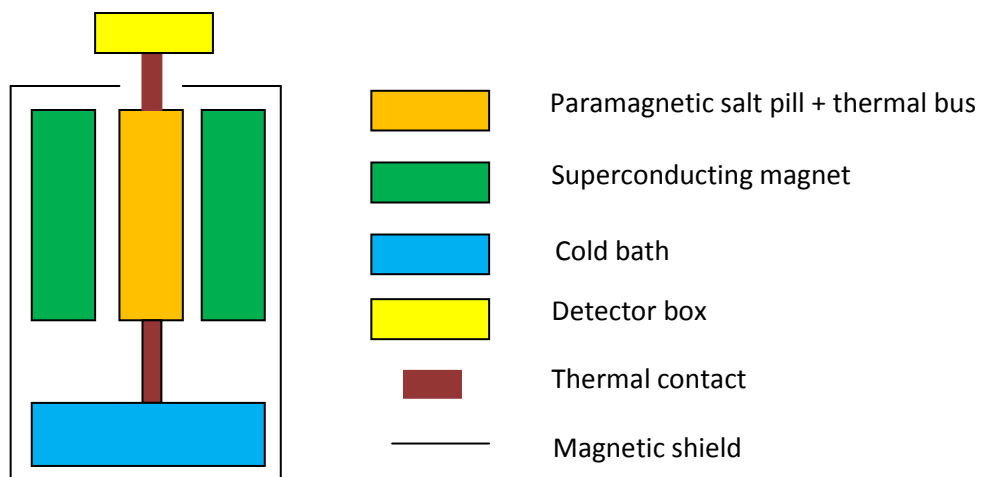


Figure 38 : Main parts of an ADR

The basic principle of operation consists in bringing the paramagnetic salt into a low entropy state (similar to that one pertinent to very low temperatures) by applying an external magnetic field to order the magnetic moments.

A paramagnetic material is composed of magnetic moments which mutually interact. At the temperature of pumped liquid helium, the interaction energy between magnetic moments is negligible with respect to the thermal energy of the molecules. The molecular thermal energy is high and therefore there is a random orientation of magnetic moments. The entropy associated to the magnetic moment disorder is large compared to all the other entropy contribution of the system (lattice, conduction electrons). When the temperature decreases, the contribution of the thermal energy becomes lower and the interaction energy between magnetic moments will become similar to the thermal energy.

When an external magnetic field is applied, magnetic moments start to align. The larger is the magnetic field intensity, the larger is the number of aligned magnetic moments. This magnetic moments alignment produces a decrease of the total entropy. The transformation is exothermal, because magnetic moments go into lower energy states releasing the excess energy, and a thermal link between the salt and the thermal bath permits to evacuate the heat produced during the magnetization.

If the paramagnetic material is now thermally isolated by opening an heat switch and the external magnetic field is decreased, the magnetic moments of the salt turn back to their random orientation. This transformation is endo-thermal. The system is isolated thermally, the moments will pick up thermal energy and the material temperature will decrease until thermal energy becomes equal to the interaction energy between magnetic moments.

When the sample is demagnetized completely, the entropy of the spin system comes from the vibrations of the lattice. At this cryogenic temperature, the entropy due to the vibration of the lattice is low. During the adiabatic demagnetization process, the total entropy of the salt remains constant. The increase of entropy of the magnetic moments, due to increasing random orientation, is compensated by a decrease of the entropy of the lattice which cools down.

Annex 3 : Structure and operation of an adiabatic demagnetization refrigerator

Cryostat vacuum pumping system

A pumping system consisting of a ceramic bearing turbo-molecular pump Varian model Turbo-V 300HT (nominal speed 300 l/s) with a membrane back-up pump is used to vacuum the ADR cryostat. The vacuum level must be around 10^{-4} mbar before the liquid Nitrogen and liquid Helium can be poured inside their vessels for cooling. If the cryostat has been open to air for a long time to mount detectors and operate on the wiring, it can take more than one day to reach an adequate vacuum level.

Two mechanical rotary pumps are used to vacuum the vapour above the liquid Nitrogen and Helium in order to reduce their equilibrium temperatures. Figure 39 shows a picture of the control panel of this pumping system. The nitrogen and helium lines are composed of a pressure gauge [0 – 800 Torr], a block valve for raw pumping regulation, a needle valve for fine regulation and a safety valve regulated to 1.5 bar. The helium pumping line has a second and more accurate pressure gauge operating in the range 0-50 Torr.

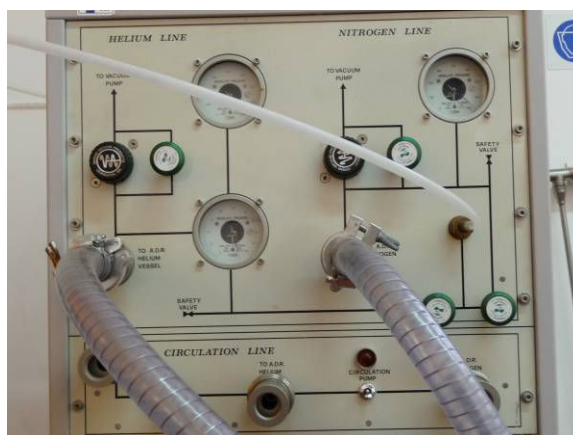


Figure 39 : Control panel of the pumping system

Pre-cooling the Dewar

The cryostat is composed of three main parts: the liquid nitrogen tank (77 K), the liquid helium tank (4 K), and finally the magnet cavity (Figure 40).

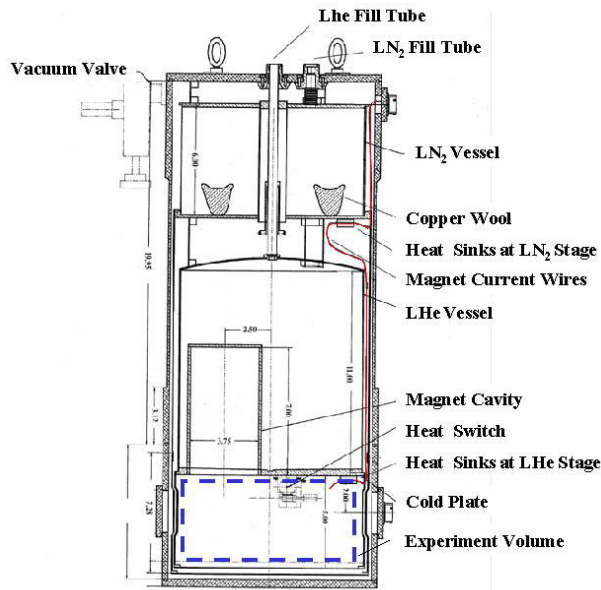


Figure 40 : Structure of the cryostat

The cooling of the cryostat from ambient temperature to pumped LHe temperature takes about one day. With the pump system running, we start pre-cooling by filling the cryostat with liquid nitrogen in the LHe and in the LN2 vessels. After a few hours the temperature on the cold plate is around 77 K. When the two vessels have reached 77 K, we can start cooling with liquid helium. Before transferring the LHe, the residual LN2 in the LHe tank must be fully removed. The first helium transfer takes about 1/2 hour and the cold plate of the cryostat reaches the LHe temperature after a few hours. Pumping on the liquid He vessel to reach the minimum temperature of about 1.8 K takes about 4 hours.

Adiabatic demagnetization cooling

Figure 41 shows the entropy diagram for 125 g of FAA paramagnetic salt. The different curves represent different values of the external magnetic field intensity from 0 to 3,5 Tesla.

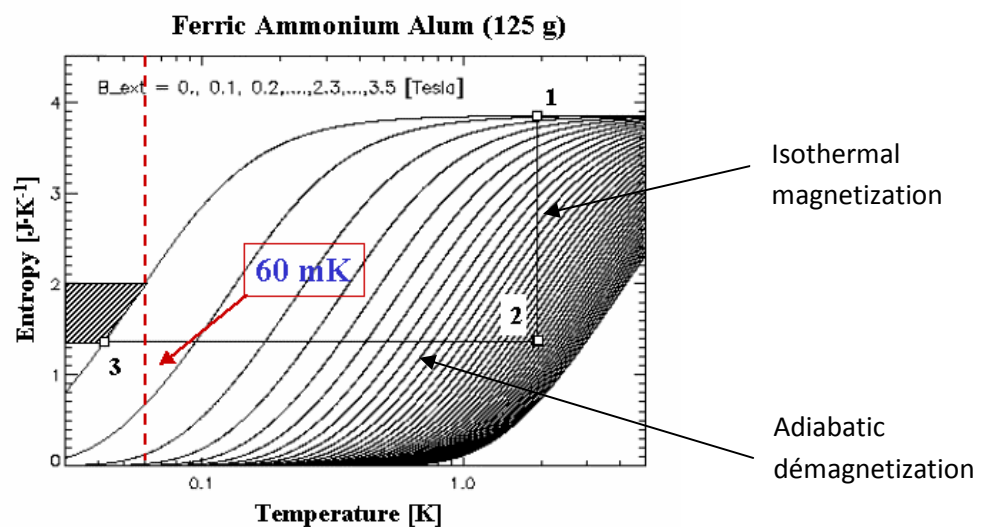


Figure 41 : Entropy diagram of 125 g of FAA paramagnetic salt

The 1-2 step is the application of the external magnetic field with the salt container in thermal contact with the cold bath at the temperature of the pumped liquid helium. The energy of interaction of the magnetic moments of the ions with the magnetic field decreases and the moments are oriented along the field axis. The 2-3 step is the removal of the external magnetic field with the salt pill thermally isolated. The thermal contact between the cold finger and the bath can be opened or closed using a mechanical switch. The temperature decreases until the thermal energy of the ions becomes equal to the interaction energy between the magnetic moments themselves. The minimum temperature that a paramagnetic salt can reach after the demagnetization step depends on the interaction energy of the paramagnetic ions and will be lower for salts with smaller magnetic moments and larger mutual distance.

Isothermal magnetization. The thermal link between the bath and the salt pill is closed. A progressive ramp of current is applied on the superconducting magnet (Figure 42). The duration of this step lasts several hours. The speed of the current can be modified and is usually around 1-2 mA/s. When the magnet current reaches the maximum value (5 A), the pill salt is thermally disconnected from the thermal bath and the process of adiabatic demagnetization can start. The disorganization of the magnetic moments creates a decrease of the temperature. The minimal temperature is around 50 mK.

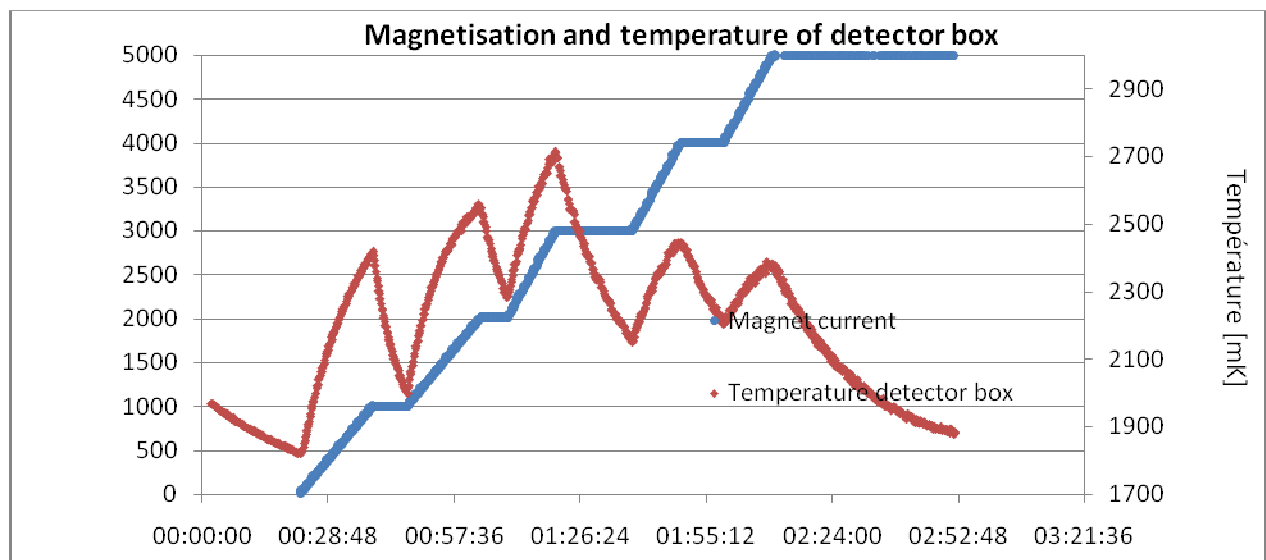


Figure 42 : magnetization step

The system control uses a Labview software to control the current of the superconducting magnet and to maintain a constant temperature in the paramagnetic salt.

Magnetic shield and residual magnetic field at detector box

The ferromagnetism is a property of materials which magnetize with an application of external magnetic field. And some of them can keep an important magnetization after extinction of exterior field. The moments of all spins are oriented in the same direction in the Weiss domains. When we magnetize the material until its saturation and we decrease the excitation H , we notice that the total

magnetic field B decreases too with a hysteresis effect (Figure 43). When H is equal to 0, there is again a magnetic field B_r called “remanent field”.

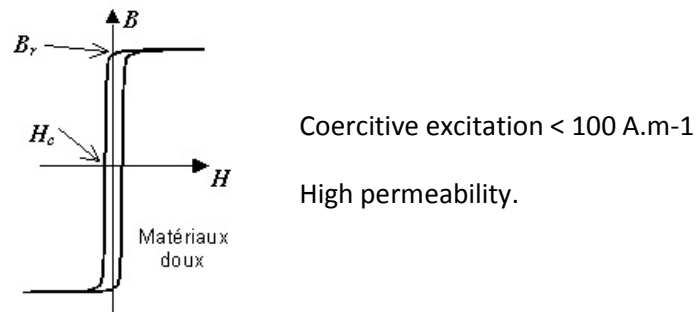


Figure 43 : $B = f(H)$ for a soft magnetic alloy

A ferromagnetic material shield permits to channel the magnetic field lines inside the material. But after magnetization of this shield, the material can keep a part of magnetization. So this solution can be a problem in the diminution of the magnetic field. A Hyperco 50A shield with high magnetic permeability ($\mu_r = 3520$) is installed around the magnet to reduce the residual magnetic field, in fact this residual magnetic field can have an effect on the detector measurements. This material contains 50% of cobalt, 2% of Vanadium, 0.01 % of carbon, 0.05 % of manganese, 0.05 % of silicon and is a soft magnetic alloy. To delete this remaining field, one solution can be to use a superconducting shield around the ferromagnetic field. When a material makes the transition from the normal to superconducting state, it actively excludes magnetic fields from its interior, this is called the Meissner effect. The Meissner effect allows to reduce totally the remanent field. The magnetic shield and the magnet are attached to a gold coated copper plate providing a good thermal link with the liquid helium bath.

A magnetic simulation of the residual magnetic at the detector place has been realized on FEEM (Finite Element Method Magnetics) (Figure 44) :

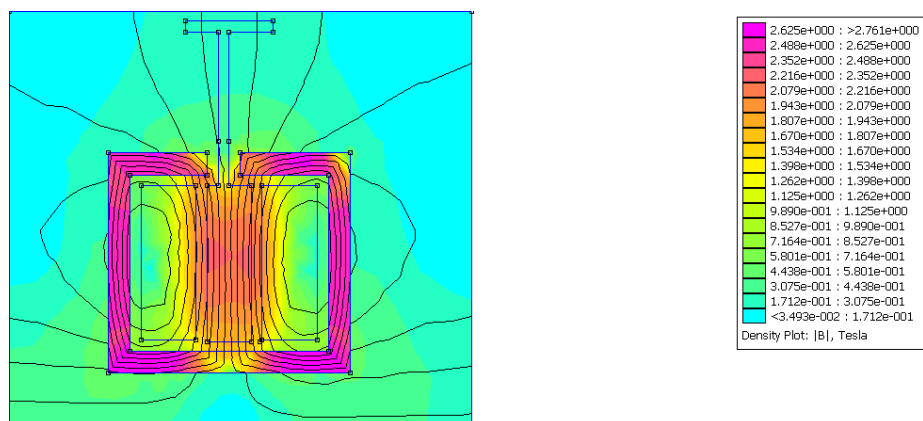
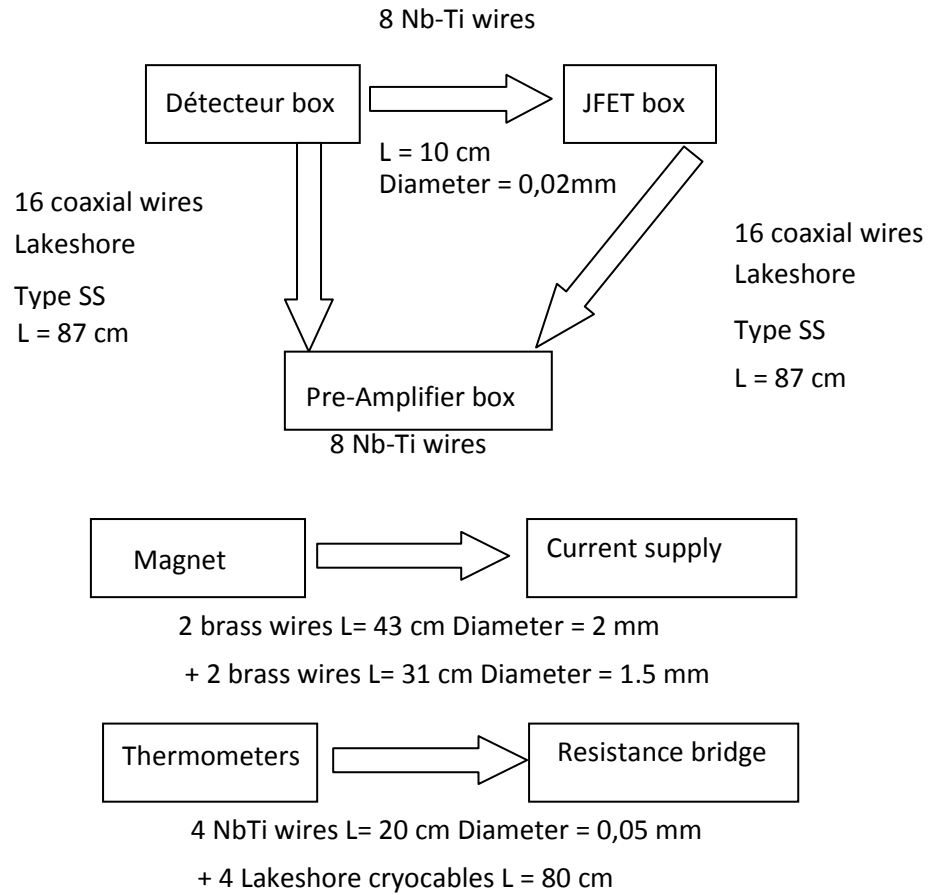


Figure 44 : Simulation of magnetic field (2D) on FEEM software

A magnetic simulation (2D) gives a residual magnetic field of 230 mT at the detector box at maximum field in the solenoid (3 T). If this residual field should be a problem during the magnetization phase, the option of building a superconducting shield of the detector box can be considered.

Annex 4 : Cryostat wiring and thermometry instrumentation

Wiring :



Thermometry instrumentation :

The thermometry instrumentation is composed of :

- RuO₂ (Ruthénium oxyde) located on the Liquid helium plate.
- Diode (DT-670) located in the electronic box.
- Germanium Resistance (GR-200A-30 Lakeshore - range = 0,05 à 1,15K) placed in the detector box
- Germanium Resistance (Ge 28945) placed on the liquid helium shield

Control of the instrumentation before pumping at room temperature (Figure 45):

Thermometers	Measurement
RuO ₂	1,01 Kohm
Diode	0,545 V
Ge (Liquid He plate)	4,175 ohm
Ge (Lliquid He shield)	1,81 ohm

Figure 45 : Thermometry check-in

The thermometers are connected to a resistor bridge (Picowatt AVS 47). The measurements range is [0 -2 Mohm] and the applied voltage can be selected from 3 μ V to 3 mV. During the operation, the temperatures are read using a Labview program.

Annex 5 : Check of the JFET electrical circuit

The following schematic describes the check circuit of JFET (Figure 46) .

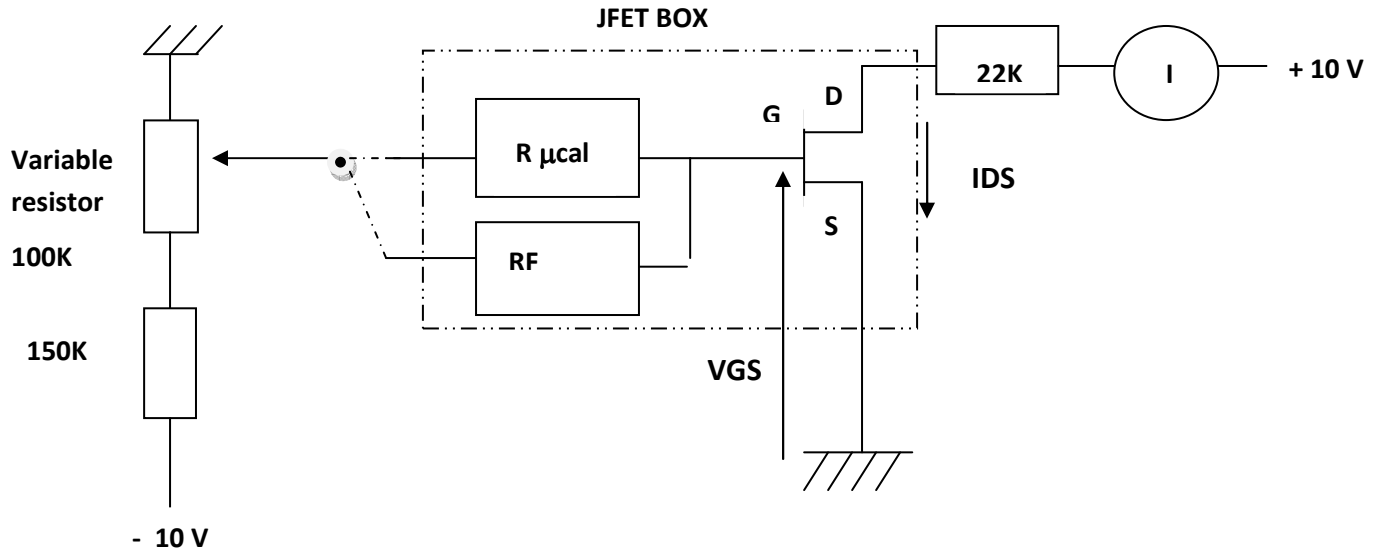


Figure 46 : JFET and continuity wiring check circuit

For each channel, we measure the current I_{DS} to check that the transistor and the instrumentation cable works well. At first, $R_{\mu cal}$ is connected (R_F is not connected) and we change the V_{GS} voltage by varying the variable resistor and we measure the current I_{DS} . Then, we disconnect the $R_{\mu cal}$ and we connect the feedback resistor R_F using the same configuration to measure I_{DS} . Thanks to this configuration, we check the wiring continuity and the JFET operation prior to the cooling. After checking, the feedback resistor will be reconnected to the preamplifier at room stage for proper operation (Figure 47).

Channel	I_{DS} max
1 RF	440uA
1 RB	446uA
2 RF	443uA
2 RB	444uA
3 RF	442uA
3 RB	440uA
4 RF	444uA
4 RB	446uA

Figure 47 : Maximum current I_{DS} measurement for each channel

The final check is the measurement of the heater for the JFET, the measured value for the heater in the JFET box is 580ohm.

Annex 6 : Code for the Spectrum plot with IDL

```
pro read_spe

dummy='bye'
cal=fltarr(2);;création d'un vecteur à 2 éléments float
data=transpose(intarr(2048)) ;création d'une colonne avec 1024 données
openr, 1, 'D:\cryostato\SPECTRUM JUIN\Ch2_20090619_01.spe' ; ouverture d'un
fichier avec le chemin du dossier à ouvrir
for i=1, 12 do begin ;boucle pour lire et passer les 12 premières lignes du
fichier de données
    readf, 1, dummy
endfor ; la lecture se fait séquentiellement jusqu'à la ligne 12

readf, 1, data ; lecture des data
print, data ; print des data

for i=1, 8 do begin ; lecture séquentielle des lignes du programme
    readf, 1, dummy
endfor

readf, 1, cal ; lecture des 2 paramètres du modèle
close, 1

print, cal[0], cal[1]
;print, data
help, data

ch= indgen(2048) ;generation d'un index croissant de 0 à 1023

Energy=cal[0]+cal[1]*ch

coor=where(data eq max(data))
print, coor
a=cal[0]+cal[1]*coor
print, a

Plot,energy, data, title='Channel 2 Ta-Al/Au T=60mK', $
    /YLOG, yrange=[1,100], xrange=[3000,8000], background = 'FFFFFF'X,
color= '000000'x, xtitle='Energy [keV]', ytitle='Counts'
End
```